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4 4 2 5 2 4 42524 Cechnical Report... STUDY OF PULSED RADIATION EFFECTS ON MICROWAVE FERRITE DUPLEXERS

SEVENTH QUARTERLY REPORT

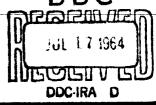
1 November 1963 to 29 February 1964

Report No. 7 Contract No. DA-36-039-SC-89113

DEPARTMENT OF THE ARMY TASK NUMBER OST 5974 01 004 36 00

This research on Transient Radiation Effects on Electronics is sponsored by the Defense Atomic Support Agency, and is conducted under the technical guidance of the U.S. Army Electronics Research and Development Laboratories, Ft. Monmouth, New Jersey, 07703, and the DASA-TREE Program Manager.

U. S. ARMY ELECTRONICS RESEARCH AND DEVELOPMENT LABORATORIES FORT MONMOUTH, NEW JERSED DC





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Study effects of pulsed nuclear radiation on the operating characteristics of C-Band microwave coaxial ferrite Y-junction circulators and gyromagnetic coupling limiters.

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Prepared by:

R. E. Greenwood

G. R. Harrison

Approved by:

Dr. E. W. Matthews

SPERRY MICROWAVE ELECTRONICS COMPANY
DIVISION OF SPERRY RAND CORPORATION
CLEARWATER, FLORIDA

SJ-222-0041-7

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1. PURPOSE

The general purpose of the second year of this study is to extend the study of pulsed nuclear radiation effects on the operating characteristics of coaxial C-band beacon ferrite duplexer devices and to include the study of pulsed nuclear radiation effects on the operating characteristics of waveguide ferrite duplexing devices operating under both high and low r-f power conditions. The coaxial duplexer to be investigated further was developed by the Sperry Microwave Electronics Company under Contract No. DA36-039-SC-85330. The four-port, differential phaseshift, waveguide duplexer and the Y-junction waveguide circulator to be investigated were also developed by the Sperry Microwave Electronics Company for use in various types of radar and communication applications. Experimental radiation effects data are to be acquired for the duplexers and for their components operating in a frequency range of 5.4 to 5.9 Gc and at least two r-f power levels, one below one watt (low power) and the other as high as possible (expected to be near 5 kilowatts peak).

Specifically, the aims of the seventh quarter of the study were the following:

• To perform a fifth series of experiments at the Sandia Pulsed Reactor Facility (SPRF), during the week of 2 December 1963, involving irradiation of the individual waveguide and coaxial duplexer components and assembled coaxial duplexer. The components were operated under two levels of power approximately equal to 100 milliwatts cw and 5 kilowatts pulsed.

To reduce and analyze the data recorded during the fifth series of experiments.

2. ABSTRACT

This report presents the results of the fifth series of radiation environmental experiments conducted during the seventh quarter of the program. Included in the report are a description of the equipment used to perform the experiments, the measurement techniques employed, and a complete dosimetry report. Photographs of important phases of the test are given to provide the reader with a better insight into the study. The microwave high power tests, which were initiated during the fourth series of tests, were continued for the fifth series of experiments. Conclusions presented are based upon the data taken thus far, including the fourth and fifth series of tests with high power operation.

3. PUBLICATIONS, LECTURES, REPORTS AND CONFERENCES

3.1 PUBLICATIONS

No additional publications were generated during this reporting period.

3.2 LECTURES

None in this reporting period.

3.3 REPORTS

None in this reporting period.

3.4 CONFERENCES

A conference was held on 17 December 1963, at the U. S. Army Electronics Research and Development Laboratory, Fort Monmouth, New Jersey. In attendance from the U. S. Army Electronics Research and Development Laboratory were:

L. L. Kaplan F. Palmisano William H. Wright John Carter

In attendance from Sperry was: G. R. Harrison.

The purpose of this conference was to analyze and review the results of the program to date and to discuss and formalize the scope and plans to be followed for the remainder of the program.

4. FACTUAL DATA

4.1 EXPERIMENTAL PROCEDURES

1.1.1 Introduction

The fifth series of tests was conducted to extend the information obtained on the coaxial and waveguide components tested previously $^{1,\,2,\,3,\,4,\,5,\,6}$ and to continue a study of these components operating under a much higher power level than earlier experiments. Low power microwave experiments are conducted using approximately 100 milliwatts of ew power to drive the components under test. High power microwave tests employ a magnetron power source to drive the components under test with approximately 5 knowatts of peak power. The high power source delivers two r-f pulses approximately 10 microseconds in width with a separation of 150 microseconds. The first pulse, hereafter called P1, was delayed from the control room (SPRF) synchronization trigger by approximately 220 microseconds. This delay placed P1 under the radiation burst. The second burst of r1, hereafter called P2, could be delayed up to 150 microseconds following P1. The delay was normally set for the maximum of 150 microseconds. The two-pulse system was desirable because it provided a means to observe the effects during the radiation burst as well as any lingering effects following the burst.

Three low power sources were employed to perform backup experiments to the high power tests and to extend the data taken on previous trips to the reactor. Only one experiment at high r-1 power was performed during each radiation burst. Both the low and high power sources were operated at a frequency of 5.6 Ge. Block diagrams of the high and low power sources utilized during the fifth series of experiments are the same as shown in the previous report.

The signal produced by the power source, designated monitor signal, was observed during each burst to insure that no changes occurred in the driving power. This was accomplished by using a directional coupler to sample the power delivered by the source which was detected and monitored on a scope. Also, the power reflected from the component under test, designated VSWR signal, was monitored by using a circulator (low power) or a directional coupler (high power) between the source and the component under test.

1-1

On the two-port devices tested, such as limiters, waveguides, and isolators, the <u>return signal</u> from the device was monitored. When three-port devices (circulators, duplexers, etc.) were tested, the power was delivered to the transmitter port, and the return signals from the antenna and receiver were monitored.

The following parts of this section (4,1) present a description of the procedure and the components tested during the fifth series of tests. Section 4,2 contains an analysis of the results obtained during the experiments.

4.1.2 Waveguide-to-Coaxial Adapter Tests

Previous data have indicated some discrepancies in the results when waveguide-to-coaxial adapters were used at the test component. All input and output transmission lines were coaxial cable. When waveguide sections and waveguide components were tested, adapters were required to test these components. Nine separate adapters have been used in previous experiments. Some of these adapters contained polyethylene matching beads and others used Rexolite beads. Previous data indicated that the match into the adapters was affected by the nuclear radiation. Some experiments were performed therefore during the fifth series of experiments to evaluate these adapters using the different bead types to the extent that any effects observed could be noted and taken into account when evaluating and testing waveguide components. Tests were performed at both high and low power.

Figure 1 shows a typical return signal at low power from a set of adapters with polyethylene beads.

Figure 2 is a photograph of the test setup at the SPRF.

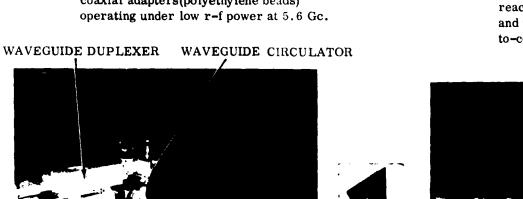
1.1.3 Waveguide Tests

Sections of C-band aluminum waveguide (air filled and high density polyfoam tilled) were tested while operating under low power conditions. Figure 3 shows the waveguide section in test positions in the SPRF. Figure 4 presents a typical photograph of the reaction which occurred in a one-foot section of air filled aluminum C-band waveguide operating under approximately 100 milliwatts ew.



Return Signal Vertical Sensitivity 0.005 volts/cm Horizontal Sweep Speed $50\,\mu sec/cm$

Figure 1. Burst No. 4, waveform of the return signal from a set of waveguide-to-coaxial adapters(polyethylene beads) operating under low r-f power at 5.6 Gc



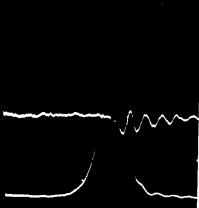
ALUMINUM WAVEGUIDE COAXIAL DUPLEXER

Figure 3. Reactor scene showing a waveguide duplexer (upper left),—an aluminum waveguide test section (just under waveguide duplexer), a waveguide Y- junction circulator, and a coaxial duplexer in test position.



WAVEGUIDE- 7 ADAPTE

Figure 2. Typical test configuration raising the reactor into The components clockwork reactor hole were a way and three separate setto-coaxial adapters.



Upper Trace: Monitor Signal
Vertical Sensitivity

Horizontal Sweep Spe

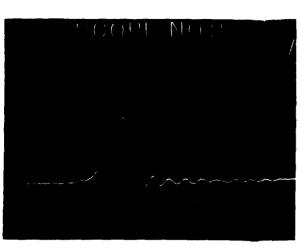
Lower Trace: Return Signal

Vertical Sensitivity (Horizontal Sweep Spe

Figure 1. Input

Input and output signal of aluminum C-band ating at 100 milliwatt

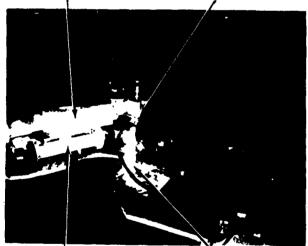
4668



Return Signal Vertical Sensitivity 0.005 volts/cm Horizontal Sweep Speed 50µsec/cm

Figure 1. Burst No. 4, waveform of the return signal from a set of waveguide-to-coaxial adapters (polyethylene beads) operating under low r-f power at 5.6 Gc.

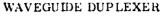
WAVEGUIDE DUPLEXER WAVEGUIDE CHRCULATOR

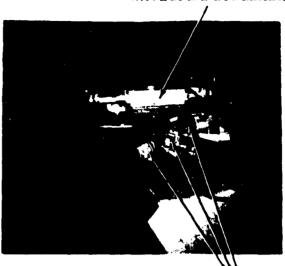


ALUMINUM WAVEGUIDE

COAXIAL DUCLEXER

Reactor scene showing a wavegu le duplexer (upper left),—an alumi cam waveguide test section (just under waveguide duplexer), a waveguide Y- junction circulator, and a coaxial duplex + in test position.

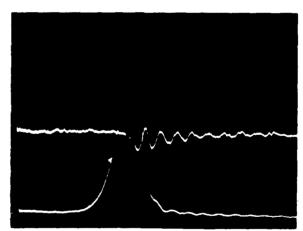




WAVEGUIDE- TO-COAXIAL ADAPTERS

Figure 2. Typical test configuration seen before raising the reactor into test position.

The components clockwise around the reactor hole were a waveguide duplexer and three separate set-ups of waveguide-to-coaxial adapters.



Upper Trace: Monitor Signal

Vertical Sensitivity 0, 005 volts/cm Horizontal Sweep Speed 50 usec/cm

Lower Trace: Return Signal

Vertical Sensitivity 0, 005 volts/em Horizontal Sweep Speed 50 µsec/cm

Figure 4. Input and output signals on a section of aluminum C-band waveguide operating at 100 milliwatts cw at 5.6 Ge.

2

4.1.4 Coaxial isolator

A.C. band, internal magnet, coaxial icolator was tested in the reactor operating under low power. The isolator was driven in the forward direction, i.e., the direction of low insertion lose. A typical return signal is shown in Figure 5.

4.1.5 Coaxial Circulator

A C-band ferrite, Y-junction, coaxial circulator was tested while operating under high power. The antenna port was monitored for changes in the insertion loss. Figure 6 presents the typical test data of the reaction observed on the antenna port of a coaxial circulator operating at high power.

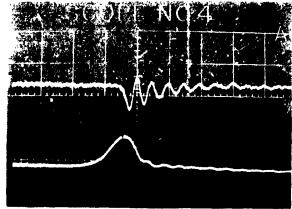
4.1.6 Coaxial Limiter

A relatively small reaction has been observed on a gyromagnetic coaxial limiter in past experiments when operating the component under low power. However, in these tests the limiter was operating at power levels below the limiting threshold. During the fourth and fifth series of tests, the coaxial limiter was driven with the high power source. During the fourth series of experiments it was observed that signal through the limiter increased by approximately 10 db. This was interpreted as a 10 db transient increase in the limiting threshold of the limiter.

During the fifth set of experiments the limiter was again evaluated at low and high r-f power. Figure 7 depicts the typical test data of the limiter at low power (100 milliwatts) during Burst 12. Similar data were obtained during Burst 13. High power tests were performed on the same limiter during Burst 14. With an oscilloscope vertical sensitivity of 0.02 volts/cm, the reaction went off scale. The data shown in Figure 8 were obtained during Burst 15 with a vertical sensitivity of 2 volts/cm. For data comparison the calibration data are shown in Figure 9. The same limiter was under test during Burst 16, but no acceptable data were obtained. No signal was observed from the limiter in Burst 16. Calibration photographs before turst time were acceptable. For Burst 17 a new limiter was tested. Time did not permit calibration before the radiation burst. The data obtained indicated an increase of the signal through the limiter during the burst. No signals could be obtained from the limiter for calibration after the burst.

During Burst 18 the original (first, limite) γ is tested at his power. The data obtained are depicted in Figure 10.

The test centiger gion of the limiter is shown in Figure 11.



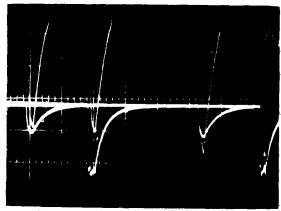
Toper Trace: Monitor Signal

Vertical Sensitivity 0,005 volts/cm Horizontal Sweep Speed 50 #sec/em

Lower Trace: Return Signal

Vertical Sensitivity 0.005 volts/cm Horizontal Sweep Speed 50 µsec/cm

Figure 5. Burst No. 6, monitor and return signal (insertion loss) from a coaxial isolate" operating at low power, ew, at 5, 6 Gc.



Lager Prace: Monitor Signal

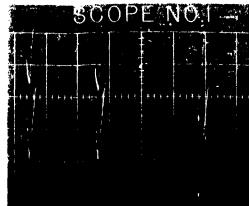
Vertical Sensitivity 0.2 volts em-

Return Signal O. 12 DE

Vertical Sensitivity 2 volts em-

to S. Joast No. To, wavefortas of input and outout signals from gyromagnetic coupling e axial limiter operating under high power it sittle

The Land thard purse moups from the left are P1 < 1.7, respective $^{\prime}$, before burst. The second and < 1.5 pulse group, are P1 and P2 during burst time.



Monitor Signal Upper Trace:

> Vertical Sensitivity 0.1. Horizontal Sweep 50 nor c

Lower Trace: Antenna Return

Figure 6.

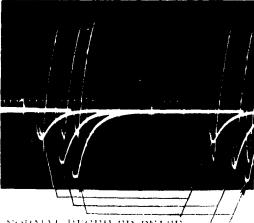
Vertical Sensitivity 0.00.

Horizontal Sweep 50 µ sec Burst 18, test data obtained

the monitor and antenna retu C-band coaxial Y-junction c

operating at high power at 5

NOTE: The first and third pulse groups from and P2, respectively, before burst. fourth pulse groups are P1 and P2 dur



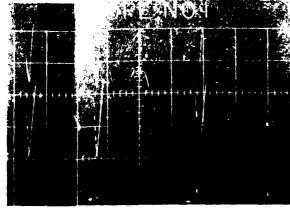
NORMAL RECEIVED PULSE 6 DB C-CREASE IN SIGNAL.

10 DE INCREASE IN SIGNAL Lower Trace: Return Signal Calibrac

Vertical Sensitivity 2 Horizontal Sweep Johnson

Parst 15, calibration data co Eigure 9.

but the return signal from the magnetic coupling limiter () a, b Ge.



Upper Trace

Monitor Signal

certical Sensitivity 0.1 volts, em

Sorizontal Sweep 50#sec/em

Lower Frac Antenna Return

Artical Sensitivity 0.005 volts, em

Herizontal Sweep 50 #sec/cm

tis, test data obtained from Figure 6.

a monitor and antenna return of a

and coaxial Y-junction circulator

raiting at high power at 5.6 Ge.

NOTE: The first and P2,

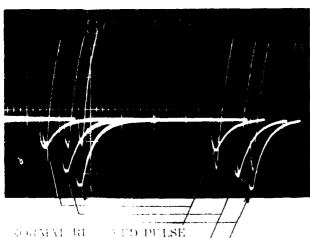
fourth pu

5 CHi

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IN C

third pulse groups from the left are P1 ectively, before burst. The second and groups are P1 and P2 during burst time.



JOHNAN RI

10131 * AST AN SIGNAL.

1. 11 HASE IN SIGNAL

Lower Proc - Lum Signal Calibration

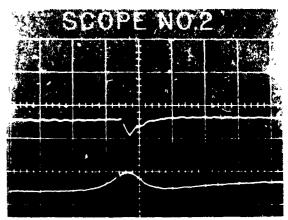
retical Sensitivity 2 volts cm

🕝 a onta) Sweep 50 µsec | cm |

, calibration data (high power)

· · turn signal from the gyro-

it coupling limiter operating at



Upper Trace: Monitor Signal

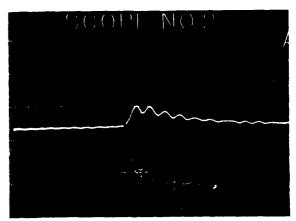
Vertical Sensitivity 0.005 volts/cm

Lower Trace: Return Signal

Vertical Sensitivity 0,005 volts/cm

Horizontal Sweep 50 µsec/cm

Figure 7. Burst 12, monitor and return signals from the gyromagnetic coupling coaxial limiter operating at low power at 5.6 Gc.



Opper Trace:

Monitor Signal

Vertical Sensitivity 0,005 volts/em

Lower Praces

Return Signal

Vertical Sensitivity 0,005 volts em-

Horizontal Sweep 50 µsec cm

Figure 16. Burst 18, monitor and return signals from gyromagnetic coupling coaxial limiter operating at low power at

a. " Gr.

The sections and Duplement Company

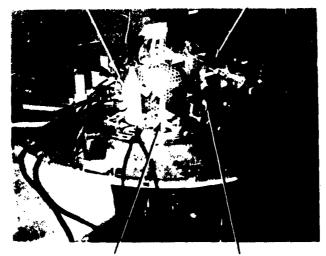
A Color decomplete managed exercises on the decomplete managed and a managed and the power. The international receiver port of the international respectively. There is no Decomplete managed and association respectively. There is possessed and a color observed on the international decomposition of a Color observed terrate displaces open three nodes for power on the field of the decomposition of the input and empty significant or anti-managed port of the convail displacer under high proven open tion. There is the short of control displacer in test position in the SPRI.

1-1 - Wayeguide Junetion Circulater

The C band Y function was eguide circulator was tested per emplander both flight and low bower. The antenna and receiver parts vere morntored for changes in insertion less and isolation, respectively, during the radiation burst. Figure 14 presents the input and return signals from the antenna criso the VSWR signal. These return signals indicate an increase in insertion loss between the transmitter and in terms ports of the decrease in decrease in isolation between the transmitter and receiver ports. Figure 15 presents the return signal from the antenna port of the crieck later equanting at 5 a Ge and high pursed rist power. Figure 11 shows a viviginal correctation in test position in the SPRI.

3 (1.9) Waveguide Differential-Phase-Shaft Duplexes

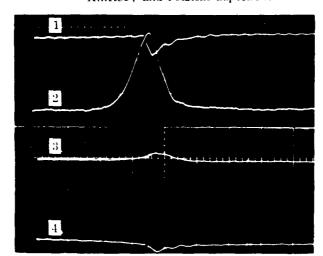
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COAXIAL LIMITER

WAVEGUIDE CIRCULATOR

Test configuration at the SPRF. The components are as follows (clockwise, starting with component in upper right hand corner): waveguide duplexer, waveguide circulator, coaxial limiter, and coaxial duplexer.



Frace 1: Monitor Signal

Vertical Sensitivity 0,005 volts/cm

Trace 2: Return Signal (Antenna Port)

Vertical Sensitivity 0,005 volts, em

Trace Pr. VSWR Signal

Vertical Sensitivity 0.01 volts em-

Figure 1 Return signal (Receiver Port)

Vertical Sensitivity 0,005 volts, cm

VSWR, and the output signal—from the antenna and receiver ports of a C-band, Y-junction, waveguide eir-

culator operating under cw low power

Upper Trace

Monitor Signal

Middle Trave

Vertical Sensitivity Return Signal (Anter Vertical Sensitivity

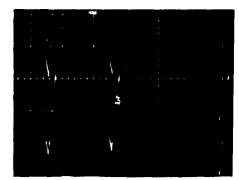
Lower Trace

Receiver Return Sig Vertical Sensitivity

Horizontal Sweep Sp

Figure 12

parst No. 6, waveform agnal from the antenna ports of a C-band coaxis aplexer operating underwer at 5.6 Ge.



Upper Trace:

Monitor Signal Vertical Sensitivit

Lower Trace

Antenna Return Sign Vertical Sensitivity Horizontal Sweep Se

Figure 15. Worst No. 12, waveform and return signal from to port of a C-band Y-junet garder circulator oper dispressed in a power at the

;

Upper Trace

Monitor Signal

Middle Trace

rtical Sensitivity 0.005 volts/cm turn Signal (Antenna Port)

- rtical Sensitivity 0.005 volts/em

Lower Trace

. ceiver Return Signal

the circul Sensitivity 0.005 volts/cm erizontal Sweep Speed 50 µsec/cm

Figure 12.

CULATOR

, combo

rting with

ri: wave

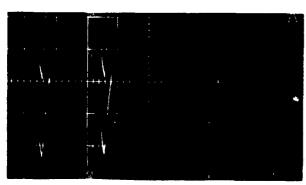
the course of

www. 6, waveform of the output trom the antenna and receiver

* ←C-band coaxial ferrite

: perating under cw low

. . . 6 Ge.



Upper Trace

Total Signal

tie d Sensitivity 0.4 volts, em

Lower Trace

and Return Signal

field Sensitivity 0.05 volts em

Zoatal Sweep Speed 50 µsec em

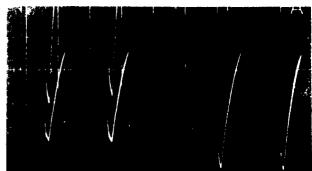
rigare Le. 1

12. waveform of monitor signal from the antenna

-band Y-junction wave-

slator operating under high

posser at 5.6 Ge.



Upper Trace:

Monitor Signal

Vertical Sensitivity 0.1 volts, cm

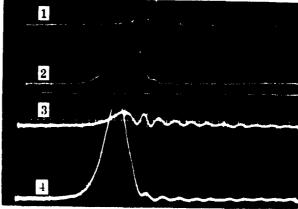
Lower Trace: Return Signal

Vertical Sensitivity 0.1 volts/cm

Horizontal Sweep 50 µsec/em

Figure 13. Burst No. 9, waveforms of the input and the output signal from the antenna port of a C-band coaxial ferrite duplexer operating under high pulsed power at

5.6 Gc.



1 to 1: Monitor Signal

Vertical Sensitivity 0,000 volts on

L. ece Li Retarn Signal (Antenna Port)

Vertical Sensitivity 0,01 volts cm

1) ace 3: VSWR Signal

Vertical Sensitivity 0,005 volts, em

trace 1: Return Signal (Receiver Port)

Vertical Sensitivity 0,01 volts, em

Horizontal Sweep 50 #sec/cm

F. ure 16, Burst No. 3, waveform from monitor VSWR, and output signals of the antenna and receiver ports of a waveguide, Phase shift, ferrite duplexer

operating under low cw power at 5,600.

1.7

4 1.46 Additional Components

The MA-220 magnetron (tube alone with no respectived circuitry) was placed advicent to the reactor during the last two bursts. The magnetron was single pulsed such that the pulse was coincident with the radiation turst. The power output was monitored proburst and during the burst. No changes in the output level vere of served. In the fourth series of tests, has large decrease in output power as observed when this same magnetron was tested along with the pulse transformer and it associated circuitry. This decrease in output power is due to the transient effect, in the transformer and associated circuitry rather than the magnetron itself, as verified by the data obtained on the above tests (fifth series of tests). The magnetron is shown in test position at the SPRF in Figure 18.

A C-band coaxial frequency meter (transmission cavity type) was tested during the fifth series of experiments. No calibration data were obtainable but a large excursion is noted in the output signal. This indicates that the resonance characteristics of the cavity were aftered during the radiation burst. The ionized air possibly are reconciled a phase change in the r-f signal as it traversed the sharply funed cavity.

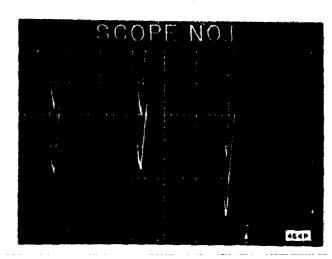
4-2 ANALYSIS OF DATA AND RESULTS

4-2.1 Calibration Procedures

The millivolt deflections observed on the oscilloscopes were converted to dle changes in the operating characteristics of the components by use of calibrated variable attenuators placed between the r-f sources and the component under test. Before burst time, attenuations of 0 = 0.5 = 0.7, 2.0, and 3 = 0 db were introduced into the transmission lines, and photographs were taken of the output level of each crystal detector. From these photographs, the change in attenuation in db was plotted as a fination of the clarge in the voltage output level in millivelts of each crystal. Because these curves vere terr close to being linear in most cases, the crystal sensitivities were approximately constant and had dimensions of millivelts all. This constant crystal sensitivities to approximately constant and had dimensions of millivelts all. This constant crystal sensitivities to a discount of the clark of the terribulation of the constant crystal.

Since large inviter as there obsersed in the return signal from the consernmator, fixed atomorphis were removed from the signal return line for exhibition of the magnitude at the increase. Typical cald information data are size in in Figure 5.

The following sections present the results of tigned or the transient radiation cases in the components and the conclusions regularly from these effects



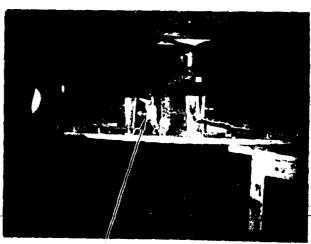
Upper Trace: Monitor Signal

Vertical Sensitivity 0.1 volts em

Lower Trace: Return Signal (Antenna)

Vertical Sensitivity 0.1 volts, cm Horizontal Sweep 50 - µsec. cm

Figure 17. Burst No. 5, waveform of the monitor and output signal from the antenna port of a waveguide, phase shift, ferrite duplexer operating under high pulsed power at 5.6 Gel.



 $MA(s\Sigma)^{\alpha}(t) + (s - s)^{\alpha}$

463P

Figure 18. The MA-220 magnetron in test position at the 8PRF.

4.2.2 Transient Radiation Effects in the Components Tested

Waveguide to Coaxial Adapters. The effects observed during the waveguide-to-coaxial adapter tests are presented in Table I. For the high power tests, the effects observed for the first pulse, P1, are tabulated separately from those of the second pulse, P2. Polarities indicate whether the changes were increases or decreases in isolation or insertion loss. A positive sign indicates the signal being monitored increased, and a negative sign indicates the signal decreased. Any changes in the high power signals levels less than 0.1 db are considered insignificant due to the error associated with calibration.

The following explanations are for Tables I through V:

- Column 1 of Table I assigns an identification number to each reaction for reference purposes.
- Column 2 is the burst number assigned by Sperry, i.e., the first burst during the tests was assigned number 1.
- Column 3 gives the change in temperature of the reactor for each burst as supplied by the SPRF personnel.
- Column 4 is the oscilloscope channel number which recorded the reaction.
- Column 5 gives the name of the component being tested.
- Column 6 lists the power source driving the component.
- Column 7 gives the crystal detector number used to monitor the signal concerned.
- Column 8 presents the crystal sensitivity as calculated from the calibration curves.
- Column 9 gives the sensitivity of the oscilloscope channel monitoring the signal.
- Column 10 presents the magnitude of the deflection observed on the oscilloscope.
- Column 11 lists the effect in db as calcutated from columns 8 and 10.
- Column 12 lists the signal monitored.

Four sets of adapters (labeled #1, #2, #3, #4) were tested at low and high power. Rexolite and polyethylene matching beads were evaluated in each adapter.

The following conclusions are offered regarding the waveguide-to-coaxial adapters from the data in Table I:

• The average transient decrease in signal level passing through the adapters using Rexolite beads was approximately 0.1 db while operating in the 100 milliwatt level at 5.6 Gc.

TABLE I. RESULTS OF RADIATION E
TO COAXIAL ADAP
HIGH AND LOW

1	2	3	4	5			
IDENTIFICATION NO.	BURST NO.	BURST NO.	INPUT NO.	COMPONENT UNDER TEST			
1	1	96. 5	1	WAVEGUIDE TO COAXIAL ADAPTER #1 (REXOLITE BEAD)			
2	1	96. 5	2	#1			
····- 3-·· -	1	96. 5	4	#3			
4	1	96. 5	8	44			
5	1	96. 5	11	#3			
	·- 2 ··· ·	96. O.	1	#1			
7	2	96. O	2	#1			
8	2	96. O	4	#3			
9	2	96. O	8	#4			
10	3	105. 5	2	WAVEGUIDE TO COAXIAL ADAPTER #1 (POLYETHY LENE BEA			
11	3	105. 5	4	#3			
12	3	105. 5	8	44			
13	3	105. 5	11	43			
14	4	106. 2	2	#1			
15	4	106. 2	4	#3			
16	4	106. 2	8	4			
17	4	106. 2	11	#3			

NOTES: 1. WHERE THERE ARE TWO VALUES GIVEN, THE FIRST CORRESPONDS TO THE HIGH POWER PULSE (P1)

DELAYED ~200 #SECONDS AFTER THE SPR TRIGGER; AND THE SECOND VALUE CORRESPONDS TO

THE PULSE (P2) ~ 350 #SECONDS AFTER THE SPR TRIGGER.

DETECTOR MONITORING THE RETURN SIGNAL FROM THE DEVICE.

2. POSITIVE SIGNS INDICATE AN INCREASE IN POWER AT THE POINT OF MEASUREMENT.

3. MONITOR: DETECTOR MONITORING THE INPUT SIGNAL LEVEL. VSWR: DETECTOR MONITORING THE VSWR OF THE DEVICE.

RETURN:

4. LOW CW - APPROXIMATELY 100 MILLIWATTS CW AT THE COMPONENT UNDER TEST. HIGH PULSED - APPROXIMATELY 5KW PEAK AT THE COMPONENT UNDER TEST.



ABLE I. RESULTS OF RADIATION ENVIRONMENT TESTING OF WAVEGUIDE TO COAXIAL ADAPTERS AT 5.6 GC FOR R-F HIGH AND LOW POWER CONDITIONS

5	6		7	8	9	10	11	12
ONENT UNDER TEST	DRIVING	SIGNAL ⁴	CRYSTAL DETECTOR NO.	CRYSTAL SENSITIVITY (MV/DB) ¹	VERTICAL GAIN (MV CM)	MAGNITUDE OF EFFECT (MV) ¹ , ²	MAGNITUDE OF EFFECT (DB)1,2	signal ³
L ADAPTER #1 (REXOLITE BEAD)	HIGH	PULSED	1	224	100	-8, -6	04, 03	MONITOR
#1	HIGH	PULSED	1	148, 144	100	+6, +6	+. 04, +. 04	RETURN
#3	LOW	cw	13	90	5	-8	09	RETURN
#4	LOW	cw	3	22	5	-5	23	RETURN
#3	LOW	CW	6	156	5	-5	- 03	vswr
#1	HIGH	PULSED	1	158	100	+6, +8	+. 04, +. 05	MONITOR
#1	HIGH	PULSED	1	132, 122	100	-26, -18	20, 15	RETURN
#3	LOW	CW	13	98	5	-7. 0	07	RETURN
#4	LOW	CW	3	40	5	-4. 5	-, 11	RETURN
, ADAPTER #1 (POLYETHYLENE BEA: -	HIGH	PULSED	1	100, 95	100	+5, +5	+. 05, +. 05	RETURN
#3	LOW	CW	13	142	5	-10.5	07	RETURN
#4	LOW	cw	3	19	5	-5	26	RETURN
#3	LOW	CW	6	198	5	-4. 5	02	VSWR
#1	HIGH	PULSED	1	114, 86	100			RETURN
#3	LOW	CW	13	96	5	-10	10	RETURN
#4	Low	cw	3	20	5	-5. 5	28	RETURN
#3	LOW	CW	6	162	5	-4. 5	03	VSWR

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ONDS TO THE HIGH POWER PULSE (PIESECOND VALUE CORRESPONDS TO

INT OF MEASUREMENT.

DL. DE. DM THE DEVICE.

IPONENT UNDER TEST. ENT UNDER TEST.

4-11/12

TABLE II. RESULTS OF RADIATION ENVIRONMENT 1 WAVEGUIDE, COAXIAL ISOLATOR, COAXIAL CIRCULATOR UNDER 5.6 GC R-F HIGH AND LOW POW

	11	2	3	4	5		6	
	IDENTIFICATION NO.	BURST NO.	BURST SIZE (°C)	INPUT NO.	COMPONENT UNDER TEST	DRIVIN	G SIGNAL ⁴	CI DE
ļ	1	9	93. 5	8	ALUM. W/G (AIR FILLED)	LOW	CW	
	2	10	111.5	8	ALUM. W/G (AIR FILLED)	LOW	CW	
i	3	17	104. 0	8	ALUM. W/G (HI DENSITY POLY)	LOW	CW	
1	4	18	94. 5	8	ALUM. W/G (HI DENSITY POLY)	LOW	CW	
	5	14	84. 0	2	ALUM. W/G (SOLID POLYETHYLENE)	LOW	cw	
; 1	6	15	90. 5	2	ALUM. W/G (SOLID POLYETHYLENE)	LOW	cw	
	7	16	94. 0	2	ALUM. W/G (SOLID POLYETHYLENE)	LOW	cw	
	8	5	109. 0	8	COAXIAL ISOLATOR	LOW	cw	
-	9	6	102. 8	8	COAXIAL ISOLATOR	LOW	cw	
	10	15	90. 5	6	COAXIAL CIRCULATOR	LOW	CW	
į	11	18	94.5	1	COAXIAL CIRCULATOR	HIGH	PULSE	
	12	18	94.5	2	COAXIAL CIRCULATOR	нісн	PULSE	
	13	12	98. 0	11	COAXIAL LIMITER	LOW	cw	
	14	18	94.5	4	COAXIAL LIMITER	LOW	CW	
-	15	15	90. 5	1	COAXIAL LIMITER	HIGH	PULSED	

- NOTES: 1. WHERE THERE ARE TWO VALUES GIVEN, THE FIRST CORRESPONDS TO THE HIGH POWER PULSE (PI) DELAYED \sim 200 μ SECONDS AFTER THE SPR TRIGGER; AND THE SECOND VALUE CORRESPONDS TO THE PULSE (P2) \sim 350 μ SECONDS AFTER THE SPR TRIGGER.
 - 2. POSITIVE SIGNS INDICATED AN INCREASE IN POWER AT THE POINT OF MEASUREMENT.
 - 3. MONITOR: DETECTOR MONITORING THE INPUT SIGNAL LEVEL.
 VSWR: DETECTOR MONITORING THE VSWR OF THE DEVICE.
 RETURN: DETECTOR MONITORING THE RETURN SIGNAL FROM THE LEVICE.
 - 4. LOW CW, APPROXIMATELY 100 MILLIWATTS CW AT THE COMPONENT UNDER TEST. HIGH PULSED, APPROXIMATELY 5 KW AT THE COMPONENT UNDER TEST.
 - * SAME MAGNITUDE OBSERVED DURING BURST 13.

TABLE II. RESULTS OF RADIATION ENVIRONMENT TESTING OF ALUMINUM VAVEGUIDE, COAXIAL ISOLATOR, COAXIAL CIRCULATOR, AND COAXIAL LIMITER UNDER 5.6 Gc R-F HIGH AND LOW POWER CONDITIONS

5	6	7	8	9	10	11	12
COMPONENT UNDER TEST	PNO SIGNAL ⁴	CRYSTAL DETECTOR NO.	CRYSTAL SENSITIVITY (MV/DB)	VERTICAL GAIN (MV/CM)	MAGNITUDE OF EFFECT (MV)1,2	MAGNITUDE OF EFFECT (DB) ¹ , 2	SIGNAL 3
ALUM. W/G (AIR FILLED)	, c'W	3	28	5	-10. 2	36	RETURN
ALUM. W G (AIR FILLED)	CW	3	160	5	-20. 3	13	RETURN
ALUM. W G (HI DENSITY POLY)	\sim $C\mathbf{W}$	3	66	5	-13.5	21	RETURN
ALUM. W. G (HI DENSITY POLY)	, CW	3	60	5	-12. 2	20	RETURN
ALUM. W G (SOLID POLYETHYLENE)	, cw	3	75	5	-3	04	RETURN
ALUM. W G (SOLID POLYETHYLENE)	∴ CW	3	80	5	-3	04	RETURN
ALUM. W G (SOLID POLYETHYLENE)	$\epsilon \mathbf{w}$	3	100	5	-4	04	RETURN
COAXIAL ISOLATOR	ev CW	3	42	5	-4.5	11	RETURN
COAXIAL ISOLATOR	77 CW	3	86	5	-7. 2	08	RETURN
COAXIA! CIRCULATOR	· (*\\	12	100	5	2	0. 02	ANTENNA RETURN
COAXUA: CIRCULATOR	PULSE	14	144, 101	100	+20,+20	+ . 14 , + . 20	MONITOR
COAXIAL CIRCULATOR	PULSE	1	8,6	5	0.5,0.5	+0.06,+0.1	ANTENNA RETURN
COAXIAL LIMITER		6	364	20	-6.0	02*	RETURN
COAXIAI LIMITER	. · · · · · · · · · · · · · · · · · · ·	13	62	5	-5.5	09	RETURN
COAXIAI LIMITER	PULSED	1	240	2000	+2600	+10	RETURN

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S GIVEN, THE FIRST CORRESPONDS TO TO DECEMBER 200 - SECONDS AFTER THE SPR TRESPONDS TO THE PULSE (P2) - 350 # SEC

CREASE IN POWER AT THE POINT OF

RING THE INPUT SIGNAL LEVEL. RING THE VSWR OF THE DEVICE. RING THE RETURN SIGNAL FROM THE DE

MILLIWATTS CW AT THE COMPONENT UNDER MATERY 5 KW AT THE COMPONENT UNDER COMPON

RESC BURST IN

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TABLE III. RESULTS OF RADIATION ENVIRONMENT TESTING OF OPERATING AT 5.6 GC AT HIGH AND LOW R-F POWER

1	2	3	4	~	6	7
IDENTIFICATION	BURST NO.	BURST SIZE (C)	INPUT NO.	COMPONENT NDER TEST	DRIVING SIGNAL ⁴	CRYSTAI DETECTOR NO
1	5	109.0	6	COAXIAL UPLEXER	LOW CW	. 12
2	6	102. 8	6		rom cm	12
3	6	102. 8	10		LOW CW	11
4	7	97. 5	6		LOW CW	12
5	8	100. 5	, 6		LOW CW	12
G	8	100. 5	10	:	LOW CW	11
7	9	93. 5	1		HIGH PULSE	14
9	a	93. 5	2		HIGH PULSE	. 1
9	10	111.5	1		HIGH PULSE	14
10	10	111.5	2	COAXIAL SUPLEXER	HIGH PULSE	1
		_	; i			!

NOTES: 1. WHERE THERE ARE TWO VALUES GIVEN, THE FIRST CORRESPONDS TO THE HIGH POWER PULSE (P1) DELAYED > 200 pto SECONDS AFTER THE SPR TRIGGER; AND THE SECOND VALUE CORRESPONDS TO THE PULSE (P2) > 350 pto SECONDS AFTER THE SPR TRIGGER.

 POSITIVE SIGNS INDICATE AN INCREASE IN POWER AT THE POINT OF MEASUREMENT.

3. MONITOR: DETECTOR MONITORING THE INPUT GRAL LEVEL.
VSWR: DETECTOR MONITORING VSWR OF THE DEVICE.
RETURN: DETECTOR MONITORING THE RETURN SIGNAL FROM THE

4. LOW CW., APPROXIMATELY 100 MILLIWATTS CW. HIGH PULSED, APPROXIMATELY 5 KW PEAK.

TABLE III. RESULTS ADIATION ENVIRONMENT TESTING OF THE COAXIAL DUPLEXER OPERATING 5.6 GC AT HIGH AND LOW R-F POWER CONDITIONS

	i	4				6	7	8	9	10	11	12
T	RCRS1 SUF	8 Pt 1 50.	COMPONENT	(E'. (T)	DRIVIN	G SIGNAL ⁴	CRYSTAL DETECTOR NO.	CRYSTAL SENSITIVITY (MV DB)	VERTICAL GAIN (MV CM)	MAGNITUDE OF EFFECT (MV) ¹ , ²	MAGNITUDE OF EFFECT (DB) ^{1, 2}	SIGNAL 3
) 	4	COAXIAL	SER :	NO	CW'	12	8	5	-5. 5	07	ANTENNA RETURN
	10	4.		i	LOW	CW	12	. 78	5	-5. 0	- 06	ANTENNA RETURN
	₁ ()2 ·	10		!	LOW	CW	11	12	5	-2. 6	23	RECEIVER RETURN
	ye#	ŧ		\ : !	LOW	CW	12	68	5	-5.0	07	ANTENNA RETURN
	1 ++	to		; 	LOW	cw	12	73	5	-5.1	07	ANTENNA RETURN
	1001	111			LOW	CW	11	15	50	-3.0	-0. 2	RECEIVER RETURN
	••	ì			HIGH	PULSE	14	160,180	100	-24, -26	- 15,14	MONITOR
	.e. 1	•			HIGH	PULSE	1	96,107	100	. €	+. 06	ANTENNA RETURN
	. 1	,			HIGH	PULSE	14	178, 194	100	-28, -34	16,18	MONITOR
	1.1		COAXIAU	r star	HIGH	PULSE	1	142,148	100	-16,-16	11, - 11	ANTENNA RETURN
				ł.			i	,		1	l	·

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THE POINT OF

THE CLOPE MONITORING THE INPUT BEFFC TOR MONITORING VSWR OF TH DELIC FOR MONITORING THE BETT R DEVICE

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TABLE IV. RESULTS OF RADIATION ENVIRONMENT TEST CIRCULATOR AND A WAVEGUIDE PHASE-SHIFT TYPE 5.6 GC R-F HIGH AND LOW POWER CONDITI

1	۶	3	4	5	(6	7
IDENTIFICATION NO.	BURST NO.	BURST SIZE (°C)	INPUT NO.	COMPONENT UNDER TEST	DRIVING	G SIGNAL ⁴	CRYSTAL DETECTOR NO.
1	5	109. 0	4	w G CIRCULATOR	WQI	CW	13
2	6	102.8	4		LOW	CW	1.3
3	9	93. 5	4		WOJ	CW	13
4	9	93. 5	11		LOW	CW	Ü
5	10	111. 5	4		LOW	CW	13
6	11	95. 0	1		нісн	PULSE	14
7	11	95. 0	2		нісн	PULSE	1
8	12	98. 0	1		HIGH	PULSE	14
9	12	98. 0	2		HIGH	PULSE	1
10	13	96. 5	1		нібн	PULSE	14
11	13	96. 5	2		нісн	PULSE	1
12	14	84. 0	4		LOW	CW	2
13	15	90. 5	4		LOW	CW	2
14	16	94 0	4		LOW	CW	2
15	17	104. 0	3		LOW	CW	7
16	17	104. 0	4		LOW	CW	2
17	17	104. 0	11	W G CIRCULATOR	LOW	CW	6

NOTE: 1 WHERE TWO VALUES ARE GIVEN, THE FIRST CORRESPONDS TO THE HIGH POWER PULSE (P1) DELAYED ~200 μ SECONDS AFTER THE SPR TRIGGER; AND THE SECOND VALUE CORRESPONDS TO THE PULSE (P2) ~350 μ SECONDS AFTER THE SPR TRIGGER.

- 2 $\,$ $\,$ Positive signs indicate an increase in power at the point of <code>MEASUREMENT</code>
- MONITOR: DETECTOR MONITORING THE INPUT SIGNAL VSWR: DETECTOR MONITORING THE VSWR OF THE DEVICE RETURN: DETECTOR MONITORING THE RETURN SIGNAL FROM THE DEVICE
- 4 LOW CW, APPROXIMATELY 100 MILLIWATTS CW. HIGH PULSED, APPROXIMATELY 5KW PEAK

TABLE IV. RESULTS OF RAL STION ENVIRONMENT TESTING OF A WAVEGUIDE CIRCULATOR AND A WARGUIDE PHASE-SHIFT TYPE DUPLEXER UNDER 5.6 GC R-F HIGH ND LOW POWER CONDITIONS (SHEET 1)

4	5	6	7	8	9	10	11	12
NO NO	COMPONENT UNDER TEST	,∴G SIGN	CRYSTA DETECTO NO.		VERTICAL GAIN (MV CM)	MAGNITUDE OF EFFECT (MV) ¹ , 2	MAGNITUDE OF EFFECT (DB) ¹ , 2	SIGNAL ³
4	w g circulator	. CW	13	90	5	-14.5	16	ANTENNA RETURN
1		CW	13	96	10	-14.6	-, 15	ANTENNA RETURN
ŧ		· CW	13	98	5	-11.9	-, 12	ANTENNA RETURN
11		w cw	6		10	-3.4		vswr
4		s CW	13	111	5	-16. 9	, 15	ANTENNA RETURN
;		-t PU	LSE 14	157, 174	100	-6, -6	04, 03	MONITOR
<u>.</u>		out PU	LSE 1	50, 218	20	+5. 2, +5. 2	+. 10, +. 02	ANTENNA RETURN
4		· if PU	LSE 14	156, 160	100	-4, -4	C3, O3	MONITOR
-		H PU	LSE 1	56, 46	50	-6, -5	-, 11, -, 11	ANTENNA RETURN
į		vali PU	LSE 14	196, 193	100	-4, +4	02, +. 02	MONITOR
.*		PU	LSE 1	54, 59	50	-4,	~. 07,	ANTENNA RETURN
1		∴ CW	2	78	5	-7	09	ANTENNA RETURN
1		λ CW	2	86	5	-8.5	10	ANTENNA RETURN
:		.⊮ C W	2	95	5	-10.6	-, 11	ANTENNA RETURN
		3 CW	7	78	5	-5.0	06	MONITOR
:		.v Cw	2	92	5	-14.0	15	ANTENNA RETURN
1.1	↓ G CIRCULATOR	· « CW	6		10	-4.0		vswr

EN, 1915 FIRST CORRESPONDS TO THE HIGECONDS AFTER THE SPR TRIGGER; AND PULSE (1921-350), SECONDS AFTER THE

SECOND TRIGGER.

OWER

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PEMENT

RING THE INPUT SIGNAL G THE VSWR OF THE DEVICE RING THE PETURN SIGNAL FROM THE DE O MILLOWATTS CWIL HIGH PULSED, APPLICAMALELY



TABLE IV. RESULTS OF RADIATION ENVIRONMENT TESTS CIRCULATOR AND A WAVEGUIDE PHASE-SHIFT TYPE 5.6 GC R-F HIGH AND LOW POWER CONDITIO

1	BURST NO.	BURST SIZE (C)	INPUT NO.	55	6 F VING SIGNAL ⁴		CRYSTAL. DETECTOR NO
IDENTIFICATION NO.				COMPONENT UNDER TEST			
18	1	96. 5	10	W G DUPLEXER	Ç 14	CW	15
19	2	96. C	6		(W	C W	12
20	2	96. 0	10		(.w	CW	15
21	3	105. 5	6) (·W	C W	12
22	3	105. 5	10		· (•W	CW	15
23	4	106. 2	6		; ow	cw	12
24	4	106. 2	10		; O\ V	CW	15
25	5	109. 0	1		шын	PULSE	8
26	5	109. 0	2		ИGH	PULSE	1
27	6	102. 8	1		ын	PULSE	8
28	6	102. 8	2		чин	PULSE	1
29	7	97. 5	1		«IGH	PULSE	8
30	7	97. 5	2		ं⊈म	PULSE	1
31	8	100. 5	1		: lGH	PULSE	8
32	8	100. 5	2		яGН	PULSE	1
33	9	93 5	6		₩Q.	CW	12
34	10	111 5	6		οw	CW	12
35	11	95 0	8		ow	CW	3
36	12	98 0	8	W G DUPLEXER	ωW	CW	3

NOTE 1 WHERE TWO VALUES ARE GIVEN, THE FIRST CORRESPONDS TO THE HIGH POWER PULSE (P1) DELAYED ~ 200 μ SECONDS AFTER THE SPR TRIGGER; AND THE SECOND VALUE CORRESPONDS TO THE PULSE (P2) ~ 350 μ SECONDS AFTER THE FR TRIGGER.

- 2 POSITIVE SIGNS INDICATE AN INCREASE IN POWER AT THE POINT OF MI STREMENT.
- 3. MONITOR: DETECTOR MONITORING THE INPUT SIGNAL VSWR: DETECTOR MONITORING THE VSWR OF THE DEVICE RETURN: DETECTOR MONITORING THE RETURN SIGNAL FROM THE DEVICE.
- 4 LOWICW, APPROXIMATELY 100 MILLIWATTS CW. HIGH PULSED, APPROXIMATELY 5KW PEAK

TABLE IV. RESULTS OF RAD! CIRCULATOR AND A WA 5.6 GC R-. HIGH A

TENVIRONMENT TESTING OF A WAVEGUIDE DE PHASE-SHIFT TYPE DUPLEXER UNDER M POWER CONDITIONS (SHEET 2)

4	°i			7	8	9	10	11	12
ı	PT - MEONENT UNDER TEST	Fig	7. XL ⁴	PRYSTAL DETECTOR NO.	CRYSTAL SENSITIVITY (MV 'DB)	VERTICAL GAIN (MV CM)	MAGNITUDE OF EFFECT (MV)1,2	MAGNITUDE OF EFFECT (DB) ¹ , ²	SIGNAL ³
Į.	0 W + OUPLEXER 4	1.	8	15	30	5	-19. 8	- 66	RECEIVER RETURN
	6	14	A.	12	108	5	-15. 1	- 14	ANTENNA RETURN
f		11	, W	15	73	10	·38. 0	- 52	RECEIVER RETURN
f		1.	٠٧	12	107	10	-22.0	- 21	ANTENNA RETURN
) }		'A'	15	60	10	-30.0	50	RECEIVER RETURN
,	'9	10	W	12	100	10	-22. 0	- 22	ANTENNA RETURN
i	1	1,6	A,	15	66	10	-34.0	- 52	RECEIVER RETURN
:	1	H	POLSE	8	220, 226	100	+20, -20	+0.1, +0.1	MONITOR
.	,	11	PULSE	1	180, 170	100	-18, -10	09,09	ANTENNA RETURN
1		! ! H:	· TriLSE	8	200, 212	100	+20, +22	+. 10, +. 10	MONITOR
:		1 41	· LISE	1	156, 148	100	-22, -22	- 14, - 15	ANTENNA RETURN
1	1	H	LLSE	8	182,206	100	+18, +20	+ 10, +. 10	MONITOR
	,	н	TOLSE	1	145, 137	100	-16, -10	11, 07	. ITENNA RETURN
	:	н	FLSE	8	186, 190	100	+30, +38	+. 16, +. 20	MONITOR
	·	H	U: LSE	1	96, 104	100	15, -16	- 15, - 15	ANTENNA RETURN
,		i e	¥	12	73	5	-11 7	. 16	ANTENNA RETURN
	 	1 1	* v	12	83	5	-15.9	- 19	ANTENNA RETURN
	•	ŧ,	,4 ·	3	76	5	- 12 0	- 16	ANTENNA RETURN
١.	A PERSENTE	Į.	· ·	3	52	5	+ 12 - 0	- 24	ANTENNA RETURN

THE FULL CORRESPONDS TO THE HIGH OND: AFFER THE SPR TRIGGER; AND THE LISE CONDS AFTER THE SE

REAST TO FOWLD AT THE POINT OF MEANG THE INPUT SIGNAL
THE AS VEOLETHE DIVICE
G. THE PETURN SIGNAL FROM THE DEATH
HITTAL TO THE POST FULSED ALPROXI

4-19/20

TABLE V. SPRF BURST DATA FOR THE FIF' SPERRY MICROWAVE ELECTRONICS COMPANY FXPERIMENTAL TESTS

S. P. R. F. BURST NO.	S, M, E, C BURST NO.	17331	(1MF)	$\Lambda(\vec{e}, C)$	TOTAL NO, UBSIONS
1:: 1	1	12 124	11+	Ob. 1	1, 76 x 10 16
12-2	,	1. 2 (1 !	1.	1.70 \ 10 10
12-0		1 1 1-15.4	1 1,, ,	No. of the second	1,92 × 10 16
12-1	,	1.7 - 1-1.1	1676	3000	$\frac{1}{1} = 1.93 \times 10^{16}$
12.45	-,	1 (41)	() = (f)	1914 14	1.98 × to ¹⁶
1 11 - 4.		(2) . 407	4 - 24 - 4 -	102,5	1.57 . 10 16
12-7	i	1 1-6	1116.	37.	1.75 \ 10 16
12.5	· · · .	12-10-00		; eng.	1,80 \$ 10
E2-0		1: 3-63	Lam	44.1	1.70 \ 10 16
12-30	1111	32 (-6.1	09.77	117.	2.05 \ 10 16
1. 1.		12-4-60.	1.1	9.0	1.78 × 10 10
12 12		· ;	12.	0.50	1.75 \ 10 16
1 .		1 - 1 - en		e _{ag.}	1.76 × 10 ¹⁶
2	· ·		Leatin	s 4, 4.	1,535,40
0.5 4.4	1	1136	,	(414, 1	1, 60 × 10
11		() C.,,		(# a - ET	1,71×10 ¹⁰
1 1 - 1 4		1.5 - 60.	1000	10 1 40	1, 89 × 10
n2 15	1.	1.1.1.1.	15	tera, s	1,725×10 00
F1 - 434	10				1.50 \$ 10
12.20		1	ļ •	9.0	1.69×10^{10}

- Under the same conditions, the average transient decrease in signal level passing through the adapters using polyethylene beads was less than 0.2 db or approximately twice that of the Revolite beads.
- No significantly different results were observed when operating under high pulsed r-f power conditions.

Aluminum Waveguide Sections. A one-foot aluminum waveguide section (using waveguide-to-coaxial adapters, Rexolite beads), air filled, solid polyethylene filled, and high density polyfoam filled, was evaluated at low power. Using the same adapters, the average transient decrease in signal level through the air filled and high density polyfoam filled waveguide was approximately the same at 0.2 db. The solid dielectric polyethylene reduced the observed effects to 0.04 db. The data are tabulated in Table II.

Coaxial Isolator. The data in Table II conclude that the average transient increase in insertion loss of the coaxial isolators tested is 0.1 db at low power and 5.6 Gc. This is a value somewhat higher than the 0.02 db reported in the Sixth Quarterly Report.

<u>Coaxial Circulator</u>. The coaxial circulator, according to Table II, exhibited an average transient increase in insertion loss of 0.02 db. This is in good agreement with data previously taken on this component. The tests were performed at approximately 100 milliwatts at 5.6 Gc. No significant transient effects were observed while the component was operating under high power.

<u>Coaxial Limiter</u>. The following conclusions were reached from Table II regarding the coaxial limiter tests:

- The average transient increase in the insertion loss of the coaxial limiter operating at approximately 100 milliwatts was 0.02 db. (This is in good agreement with previous data.)⁶
- The average transient decrease in the insertion loss, i.e., increase in the signal from the coaxial limiter operating at approximately 5 Kw, was greater than 10 db.

When operating at low power, the coaxial limiter is operating below the threshold limiting level; therefore, at this power level, it may be expected to show an increase in insertion loss due to ionization which the tests substantiated. When the limiter was operated at 5 Kw, however, the limiter is operating above the limiting threshold. It is reasonable to assume that the pulsed radiation on the component may deteriorate the limiting action. The tests indicated that the limiting action of the device was

temporarily deteriorated to a great extent upon exposure to radiation while operating at high power levels.

A full explanation of cause of the large transient effects observed in the limiter are not presently formulated. As mentioned previously in Section 4.1.6, both limiters tested at the SPRF apparently were in a non-operating condition even at low power just after the high power r-f tests in the pulsed radiation environment.

These limiters were rechecked at low and high r-f power (no radiation environment) approximately two months later and seem to be in normal operating conditions. The typical measured operating characteristics at low power are shown in Figure 19.

The limiter exhibited apparent normal operating characteristics at high power in these tests two months after evaluation in the radiation environment. The limiting characteristics are depicted in Figure 20. Examination of the structure revealed no evidence of r-f arcing.

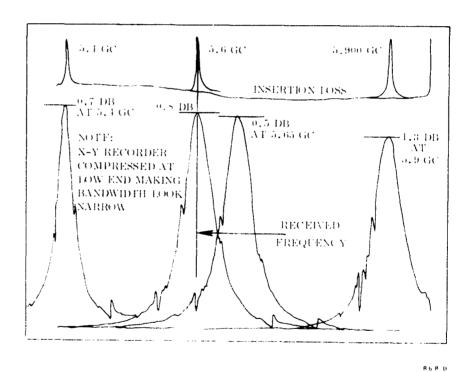


Figure 19. Low power characteristics of gyromagnetic coupling limiter, Serial No. 1, approximately two months after pulsed radiation tests.

Since radiation damage thresholds in ferrimagnetic ceramic materials have been measured to be quite high (approximately 10^{20} neutrons $\,\mathrm{cm}^2$), the observed effects are not attributed to changes in the characteristics of the single crystal yttrium iron garnet material used in the limiter.

The limiter is a fine tuned device as shown in Figure 19. Any changes in the magnetic biasing field strongly affects the r-f signal coupled through the limiter. It is expected though that any changes of this type (similar effects would be noted as a function of temperature) would reduce the output signal of the limiter. However, any signal changes due to alterations in the magnetic biasing field should occur at both high and low power.

The fimiter is composed of two crossed, very narrow strips between which the r-f energy is coupled by a small (0.023" diameter O. D.) single crystal sphere of yttrium iron garnet magnetically biased to ferrimagnetic resonance at the operating frequency. Normally, all of the r-f energy passing from the input strip to the output strip must be coupled through the sphere. The sphere is encapsulated in a teflon holder which also spaces the strips approximately 0.030" apart. The radiation test data indicate that during the nuclear burst, energy is coupled directly from strip to strip, bypassing the yttrium iron garnet coupling sphere. In other terms, the dynamic range (limiting range) of the limiter seems to decrease. However, no pulse radiation data have been collected between the 100 milliwatt r-f power level and the 5 Kw level to verify this.

The apparent permanent damage and then recovery is somewhat puzzling unless the characteristics of the teflor sphere holder and spacer are temporarily altered

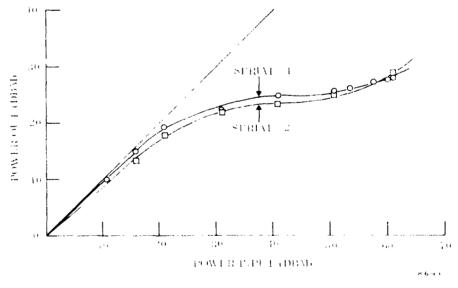


Figure 20. Limiting characteristics of coexial limiters taken approximately two months after pulsed radiation tests.

due to the radiation. However, evidence of any effects such as this should also have been observed in low r-f power experiments. Low power tests have always indicated very small transient effects. The coincidence of the high r-f peak power and the pulsed nuclear radiation seems necessary to produce the undesirable operating characteristics.

Redesign of the limiter structure itself may be required to eliminate the observed transient effects at high r-f power.

Coaxial Duplexer-Limiter. The following conclusions are offered from the data of Table III concerning the coaxial duplexer tested:

- The average transient increase in insertion loss of the coaxial duplexer operating at approximately 100 milliwatts was 0.07 db (in agreement with previous results).
- The average transient decrease in the signal level from the receiver port of the coaxial duplexer operating at approximately 100 milliwatts was 0.2 db.
- The average transient decrease in insertion loss of the coaxial duplexer operating at approximately 5 Kw was less than 0.2 db for P1 or P2.

The level of the signal from the receiver port (through gyromagnetic coupling limiter) did not increase as noted for the individual tests on the limiter because of the low level of the r-f signal incident at the limiter. This port is isolated by approximately 30 db from the input signal.

Waveguide Junction Circulator. The data in Table IV regarding the waveguide circulator indicate the following conclusions:

- The average transient increase in the insertion loss of the waveguide circulator operating approximately 100 milliwatts at 5,6 Gc was 0.13 db (approximately twice that reported in the Sixth Quarterly Report).
- The average transient increase in the insertion loss of the waveguide circulator operating at approximately 5 Kw at 5,6 Gc was less than 0,1 db (approximately the same as at low power).
- No significant changes were observed in the signal level from the receiver port. (See Figure 9.)

Waveguide Differential Phase Shift Duplexer. Following are the conclusions reached from the data of Table IV on the waveguide duplexer:

• The average transient increase in insertion loss (antenna return) of the waveguide duplexer operating at low power (approximately 100 milliwatts) at 5.6 Ge was less than 0.2 db.

- The average transient decrease in isolation (receiver return) of the waveguide duplexer operating at low power (approximately 100 milliwatts cw) at 5.6 Gc was 0.5 db.
- The average transient increase in the insertion loss (antenna return) of the waveguide duplexer operating at approximately 5 Kw peak at 5.6 Gc was less than 0.25 db (essentially the same as observed at low power).

The transient effects observed for both the waveguide circulator and waveguide duplexer are near the magnitude observed for the adapters as reported previously. A waveguide-to-coaxial adapter is required on each port of these components when performing tests at the SPRF.

4.3 DOSIMETRY

The burst magnitude data provided by the SPRF personnel at the time of the experiments are summarized in Table V. The change in bulk reactor temperature during the burst is given with the total number of fissions which occurred during the burst. The latter parameter is calculated by means of the following relation: ⁷

Total number of fissions =
$$\frac{\Delta T (^{\circ}C)}{55}$$
 x 10^{16} .

The dosimetry support given by the Sandia Corporation Nuclear Measurements and Dosimetry Section consisted of the following:

- (a) Four sulfur pellets per burst to measure the integrated neutron ($E_n > 3.00$ MeV) flux at each component.
- b) One or two each per day of pultonium, neptunium, and uranium fission foils enclosed in a boron ball to measure the integral neutron fluxes where

 $E_n > 0.01$ Mev for Pu threshold

 $E_{n} > 0.7$ Mev for Np threshold

 $E_{_{\rm II}}$ >1.5 Mev for U threshold

- (c) Two gold foils for each burst, one of which was cadmium covered, to measure the integrated neutron (E_n ≥ 0.4 ev) flux.
- (d) One glass rod (in lithium cylinders) per burst to measure the integrated γ -ray dose in rads H_2O . (In this definition 1 rad is the amount of γ radiation necessary to produce a 100 erg/gram energy absorption rate in water.)

One to two sets of fission foils (item b) were used per day of testing. The $\mathbf{E}_n>0.01$ Mev, $\mathbf{E}_n>0.7$ Mev and $\mathbf{E}_n>1.5$ Mev integral fluxes for the other bursts obtained that day may be determined from the values measured during the burst in which the foils were present by interpolation provided the total mass surrounding the reactor is not changed appreciably. A ratio of burst to burst integral fluxes ($\mathbf{E}_n>3.0$ Mev), as measured by the sulfur pellets, may be used to calculate the equivalent fission foil fluxes for the other bursts obtained during the day. This procedure was suggested by SPRF personnel. 8

To obtain the maximum dose rates from the integral quantities reported by the Nuclear Measurements and Dosimetry Section, the following procedure was followed. The reactor period associated with the burst is denoted by T. The width of the neutron pulse at one-half maximum, Tw. is given by Tw = 2.86T. For a 50-microsecond wide pulse, the period is 1.75×10^{-5} seconds or 17.5 microseconds. The reciprocal reactor period $\alpha = 1/T$ is 5.72×10^4 sec⁻¹. The ratio of peak fission rate to total fissions is

$$\frac{F_{\text{max}}}{F_{\text{total}}} = \frac{\alpha}{4} = 1.43 \times 10^4 / \text{second for a 50 } \mu \text{ sec pulse.}$$

The neutron flux above 3.0 MeV is measured by sulfur pellets, which is about 14.5 percent of the total flux above 10 KeV. The first collision tissue dose is related to the sulfur flux by $D_n=1.66 \times 10^{-8} \phi_s$. About 80 percent of the total neutron dose is delivered during the prompt critical burst and the remaining 20 percent during the delayed critical portion of the burst.

Approximately 75 percent of the total gamma dose is delivered during the prompt critical burst, and the total gamma dose is approximately 10 percent of the total neutron dose. The peak gamma dose rate then becomes 1.9 x $10^{-2} D_{\rm n}^{-}/{\rm T}$, where $D_{\rm n}^{-}$ is the total neutron dose delivered during the burst and T is the reactor period. The results of these type calculations giving dose rates along with the integral doses, where available, are given in Table VI (which appears at the end of this section).

4.4 SUMMARY OF RESULTS

Table VI presents a summary of all the radiation transient effects observed together with the dosimetry report (magnitude of radiation burst) for each component tested.

SYMBOL DEFINITIONS FOR TABLE VI

= DIFFERENCE BETWEEN CENTER OF RADIATION BURST AND CENTER OF P1 (MICROSECONDS)

= INTEGRATED NEUTRON FLUX 3.0 Mev (NEUTRONS, cm²)

= INTEGRAL NEUTRON FLUX 1.5 Mev (NEUTRONS/cm²)

 $E_n^0.6$ = INTEGRAL NEUTRON FLUX 0.7 MeV (NEUTRONS/cm²)

E_n0,01- = INTEGRAL NEUTRON FLUX 0.01 Mey (NEUTRONS/cm²)

= FIRST COLLISION TISSUE DOSE OF NEUTRONS (RADS)

= 1.66 x 10^{-8} E_{ns.} where 1.66 x 10^{-8} is an empirical number

= RADIATION PULSE WIDTH AT ONE-HALF MAXIMUM OBTAINED FROM SPRF PHOTOGRAPH (SECONDS)

= REACTOR PERIOD = $\frac{1}{2.86}$ T_w WHERE $\frac{1}{2.86}$ IS AN EMPIRICAL NUMBER (SEC.)

= RATIO OF PEAK NEUTRON FISSION RATE TO THE TOTAL NEUTRON FISSIONS = $\frac{1}{4T}$

= INTEGRATED GAMMA DOSE (RADS)

= PEAK GAMMA DOSE RATE (RADS/SEC.)

NOTES:

- Power level delivered to the component under test $\frac{1}{2}$ Hi pulsed $\sim 5 \, \text{kw}$ Low cw $\sim 100 \, \text{milliwatta}$
- Positive sign indicates the center of the radiation burst was ahead of the center of P1.
- *** E_{n}^{0} . 01 was calculated assuming $E_{ns} = 0.145 E_{n}^{0}$. 01.

	1	2	3	4	5
	BURST NUMBER	COMPONENT EXPOSED	POWER LEVEL*	S** (MICROSECONDS)	INTEGRATED NEUTRON FLUX Ens (NEUTRONS, cm ²)
	1	W/G TO COAXIAL ADAPTER #1	HI PULSED	0	1 05 x 10 ¹²
ELE VI		(REXOLITE BEAD) W/G TO COAXIAL ADAPTER #3	LOW CW		1. 36 x 10 ¹²
ADIATION BURST AND		(REXOLITE BEAD) W/G TO COAXIAL ADAPTER #4	LOW CW		1. 35 x 10 ¹²
2		(REXOLITE BEAD) W/G DUPLEXER	LOW CW		1.65 x 10 ¹²
(NEUTRONS cm²)	2	W/G TO COAXIAL ADAPTER #1	HI PULSED	0	3, 59 x 10 ¹¹
EUTRONS (cm ²)		(REXOLITE BEAD) W/G TO COAXIAL ADAPTER #3	LOW CW		1. 28 x 10 ¹²
		(REXOLITE BEAD) W/G TO COAXIAL ADAPTER #4	LOW CW		1.67 x 10 ¹²
EUTRONS em ²)		(REXOLITE BEAD) W/G DUPLEXER	LOW CW		1. 60 x 10 ¹²
2,		W/G mo coastay anammn "-		±15	e 12 sall
TRONS (RADS)	3	W/G TO COAXIAL ADAPTER #1 (POLYETHYLENE BEAD) W/G TO COAXIAL ADAPTER #3	LOW CW	±15	1 11 × 10 ¹²
N EMPIRICAL NUMBER		(POLYETHYLENE BEAD) W/G TO COAXIAL ADAPTER #4	LOW CW		1. 10 x 10 ¹²
F MAXIMUM OBTAINED		(POLYETHYLENE BEAD) W/G DUPLEXER	LOW CW		1. 91 x 10 ¹²
$\frac{1}{2.86}$ IS AN EMPIRICAL					
2.86 IS AN EMPIRICAL	4	W/G TO COAXIAL ADAPTER #1 (POLYETHYLENE BEAD)	HI PULSED	+20	$\begin{array}{c} 5.55 \times 10^{11} \\ 1.11 \times 10^{12} \end{array}$
TE TO THE TOTAL NEUTRON		W/G TO COAXIAL ADAPTER #3 (POLYETHYLENE BEAD)	rom cm		1 21 x 10 ¹²
	1	W/G TO COAXIAL ADAPTER #4 (POLYETHYLENE BEAD)	FOM CM		1.64 x 10 ¹²
		W/G DUPLEXER	LOW CW		1. 64 € 10
	5	W/G DUPLEXER	HI PULSED	+20	1. 73 x 10 ¹²
		W/G CIRCULATOR COAXIAL DUPLEXER	LOW CW		2. 05 x 10 ¹² 1. 43 x 10 ¹²
ent under test Hi pulsed < 5 kw Low cw < 100 milliwatts		COAXIAL ISOLATOR	LOW CW		1. 43 x 10 ¹²
the radiation burst was ahead	6	W/G DUPLEXER	HI PULSED	0	1. 52 x 10 ¹²
- 0.145 F 0.01		W/G CIRCULATOR COAXIAL DUPLEXER	LOW CW		1. 38 x 10 ¹² 2. 14 x 10 ¹²
- 0. 145 E _n 0. 01.		COAXIAL ISOLATOR	LOW CW		1. 38 x 10 ¹²
	7	W/G DUPLEXER	HI PULSED	0	1. 55 x 10 ¹²
		COAXIAL DUPLEXER	LOW CW		2. 12 x 10 ¹²
	8	W/G DUPLEXER	HI PULSED	o	1. 67 x 10 ¹²
		COAXIAL DUPLEXER	row cw		2. 08 × 10 ¹²

TABLE VI. NEUTRON AND Y-RAY DOSIMETRY PROVIDING INTEGRAL DOSE AND DOSE RATO THE MICROWAVE COMPONENTS AND THE OBSERVED EFFECTS (SHEET 1)

· · · · · · · · · · · · · · · · · ·	:	5	6	7	8	9	10	11	12
POWER	er er (fr.) N. J. (1.) (1.)	INTEGRATED NEUTRON FLUX	i i	NEUTRON FLUX (NEUTRONS cm ²)	BORON BALL)	FLUX *** En 0.01 (CALCULA) = 0	NEUTRON TISSUE DOSE Dn	PULSE WIDTH	REAC PER
TEAET.	-Microsta obc	(NEUTRONS/cm ²)	E _n 1.5	E _n 0.6	E _n 0. 01	(NEUTRONS em	(RADS)	T _w (SEC.)	T (SF
II PULSED		1. 05 x 10 ¹²	2. 25 x 10 ¹²	4. 44 x 10 ¹²	6. 32 x 10 ¹²	7. 24 x 10 ¹²	1. 74 x 10 ⁴	41 x 10 ⁻⁶	14. 3 x
LOW CW		1. 36 x 10 ¹²		 		9.38 x 10 ¹⁷	2.26×10^4	41 x 10 ⁻⁶	14 3 x
LOW CW		1. 35 x 10^{12}			1	9. 31 x 10 ¹²	2. 24 x 10 ⁴	41 x 10 ⁻⁶	14. 3 x
LOW CW	ı	1. 65 x 10 ¹²				1. 14 x 10 ¹³	2. 74 x 10 ⁴	 41 x 10 ⁻⁶	14
HI PULSED	: : :	6. 59 x 10 ¹¹				4. 54 x 10 ¹²	1. 09 x 10 ⁴	40 x 10 ⁻⁶	14.0
ĽOM CM	:	1. 28 x 10 ¹²				8.83 x 10 ¹²	2. 12 x 10 ⁴	40 x 10 ⁻⁶	14. 0 x
LOW CW	:	1. 67 x 10 ¹²			1	1. 15 x 10 ¹³	2. 77 x 10 ⁴	40 x 10 ⁻⁶	14.0 x
LOW CW		1. 60 x 10 ¹²				1. 10 x 10 ^{1.3}	2. 66 x 10^4	40 x 10 ⁻⁶	14.0 x
				· ·		4. 26 x 10 ¹²	2.00 A 10	10 10	
HI PULSED		6. 17 x 10 ¹¹		!	1	7. 66 x 10 ¹²	1. 02 x 10 ⁴	40 x 10 ⁻⁶	14. 0 x
LOW CW		1. 11 x 10 ¹²			i i	7. 66 x 10 ¹² 7. 59 x 10 ¹²	1.84 x 10 ⁴	40 x 10 ⁻⁶	14.0 x
LOW CW		1. 10 x 10 ¹²		-	1	1	. 1 83 x 10 ⁴	40 x 10 ⁻⁶	14 0 x
LOW C.M.		1. 91 x 10^{12}			ı	1. 31 x 10 ¹³	3, 17 x 10 ⁴	40 x 10 ⁻⁶	14.0 \
HI PULSED		5, 55 x 10 ¹¹	:			3. 83 x 10 ¹²	a. 91 10 ⁸	41 x 10 ⁻⁶	14 3 x
LOW CW		1. 11 x 10 ¹²	:	[!		7. 66 x 1e ¹²	9. 21 x 10 ³	41 x 10 ° 41 x 10 ° 6	
FOM, CM		1. 21 x 10 ¹²	:			8. 35 x 10 ¹²	1.84 x 10 ⁴	41 x 10 ⁻⁶	14. 3 x
LOW CW		1. 64 x 10 ¹²	1	!		1. 13 x 10 ¹³	2. 01 x 10^{4}	1	14 3 \
			10	19	19	13	2.72×10^{4}	41 × 10 ⁻⁶	14.3 s
HI PULSED	•	1. 73 x 10 ¹²	2. 62 x 10 ¹²	4.70×10^{12}	6, 66 x 10 ¹²	1. 19 x 10 ¹³	2. 87 x 10 ⁴	42 x 10 ⁻⁶	14. 7 8
LOW CW		2. 05 x 10 ¹² 1. 43 x 10 ¹²		r	!	1. 41 x 10 ¹³ 9. 86 x 10 ¹²	3. 40×10^{4}	42 x 10 ⁻⁶	14. 7 S
rom cm		1. 43 x 10 ¹²		T		9, 86 x 10 ¹²	$\frac{2.37 \times 10^4}{2.37 \times 10^4}$	42 x 10 ⁻⁶ 42 x 10 ⁻⁶	14. 7 x
HI PULSED		1. 52 x 10 ¹²		1		1. 05 x 10 ¹²	2.55 \ 10.1	41 x 10 ⁻⁶	14, 3 x
LOW CW	1	1. 38 x 10 ¹² 2. 14 x 10 ¹²	<u> </u> +	!	(9. 52 x 10 ¹² 1. 48 x 10 ¹³	$\begin{array}{c} 2.29 \times 10^4 \\ 3.55 \times 10^4 \end{array}$	41 x 10 ⁻⁶	14.3 3
LOW CW		1. 38 x 10 ¹²		<u> </u>		9. 52 x 10 ¹²		41 x 10 ⁻⁶	14. 3 s
HI PULSED	}	1. 55 x 10 ¹²			ı	1. 07 x 10 ¹³	2.29×10^4	41 x 10 ⁻⁶	14.3
LOW CW		2. 12 x 10 ¹²		: 1	1	1. 46 x 10 ¹³	2.57×10^4	49 x 10 ⁻⁶	17.18
HI PULSED	1	1. 67 x 10 ¹²				1. 15 x 10 ¹³	3. 52 x 10 ⁴	49 x 10 ⁻⁶	17.1 \
LOW CW	1			1			2.77×10^4	45 x 10 ⁻⁶	15.7 \
M/W €W		2.08×10^{12}				1, 43 x 10 ¹³	3. 45 x 10 ⁴	45×10^{-6}	15.7 \

ETRY PROVIL

FEGRAL DOSE AND DOSE RATE EXPOSURES TRISERVED EFFECTS (SHEET 1)

PONENTS AF	TRSERVE	D EFFECTS (S	HEET1)					
9		11	12	13	14	15	16	
TED NEUTRO: LUX *** CALCULATED TRONS/ cm ²)	121050 31 f 12150 33 s	$\begin{array}{c} \text{PULSE} \\ \text{WIDTH} \\ \text{T}_{W} \text{ (SEC.)} \end{array}$	REACTOR PERIOD T (SEC.)	R (1, SEC.)	PEAK INCIDENT NEUTRON FLUX RE _n 0.01 (CALCULATED) (NEUTRONS cm ² SFC.)	IN TI GRATED GAMMA DOSE D _{ET} (RADS)	PFAK INCIDENT GAMMA DOSE Dgr (RADS SEC.)	RADIATION F
24 x 10 ¹²	, ;	41 × 10 ⁻⁶	14, 3 x 10 ⁻⁶	1.75×10^{4}	1.27×10^{17}	2.45×10^{3}	2. 28 x 10 ⁷	0, 04 DB INCREASE IN MON
38 x 10 ¹²	, ‡	41 × 10° 6	14.3 x 10 ⁻⁶	1.75×10^4	1.64×10^{17}	2.75×10^3	2.97×10^{7}	0. 04 DB DECREASE IN INSE 0. 09 DB INCREASE IN INSE
31 x 10 ¹²	10.4	41×10^{-6}	14.3 x 10 ⁻⁶	1. 75 x 10 ⁴	1.63×10^{17}	2.60×10^3	2.94×10^7	0. 03 DB INCREASE IN VSWI 0. 23 DB INCREASE IN INSE
14 × 10 ¹³	4	6	6		2 00 x 10 ¹⁷	. 3, 40 x 10 ³	3, 50 x 10 ⁷	Con DB INCREASE IN ISOT
54 × 10 ¹²	1 1	41 × 10 ⁻¹⁵	14 3 x 10-6	1.75 x 10 ⁴				
83 x 10 ¹²	, -:	40 × 10 ⁻⁶	14.0 x 10 ⁻⁶	1. 79 x 10 ⁴		2. fo x 10 ³	1. 46×10^{7}	0. 05 DB DECREASE IN MON 0. 18 DB INCREASE IN INSE
15 x 10 ¹³	15 t ±	40 x 10 ⁻⁶	14.0 x 10 ⁻⁶	1. 79×10^4	1, 58 x 10 ¹⁷	1 3 15 x 10 ³	2 85 x 10 ⁷	0. 07 DB INCREASE IN INSE
10 x 10 ¹³	, ‡	40×10^{-6}	14.0 x 10 ⁻⁶	1. 79 x 10^4	2. 06 x 10 ¹⁷	$^{\circ}$ 3 00 x 10 3	3.72×10^{7}	0. 11 DB INCREASE IN INSE
10 x 10.0	4 , \$	40×10^{-6}	14.0 x 10-6	1. 79 x 10 ⁴	1.97×10^{17}	4.07×10^3	$3/57 \times 10^7$	6. 14 DB INCREASE IN INSE 0. 52 DB INCREASE IN ISOI
26 x 10 ¹²	£	40 × 10 ⁻¹⁶	14.0 x 10-6	1, 79 x 10 ⁴	7, 63 \times 10 16	· 2 7. x 103	1.37×10^{7}	0. 05 DB DECREASE IN INSI
66×10^{12}	., }		14.0 x 10 ⁻⁶	1. 79 x 10 ⁴	1.37×10^{17}	4. U5 x 10 ³	2.47×10^7	0. 07 DB INCREASE IN INSE
59 x 10 ¹²	101	40 x 10 ⁻⁶	14. 0 x 10 ⁻⁶	1. 79 x 10 ⁴	1.36×10^{17}	3.41×10^{3}	2. 46 x 107	0. 02 DB INCREASE IN VSW 0. 26 DB INCREASE IN INSE
31 x 10 ¹³	-,.‡	40 × 10 ⁻⁶	14.0 × 10 ⁻⁶	1.79×10^4	!	$4.4 \pm x \cdot 10^3$	4.26×10^{7}	0. 21 DB INCREASE IN INSE 0. 50 DB INCREASE IN ISOI
83×10^{12}	, .	41×10^{-6}	1 14 3 x 10 ⁻⁶	1 75 x 10 ⁴	6.70 × 10 ¹⁶	2 61 × 103	1.21 x 10 ⁶	NO CALIBRATION ON ADA
66×10^{12}	, t	41 × 10-6	14, 3 x 10 ⁻⁶	1.75 x 10 ⁴	1. 34 × 10 ¹⁷	4 80 \ 103	2. 42 x 10 ⁷	0. 10 DB INCREASE IN INSE
35×10^{12}	1 1 1	41 × 10 ⁻⁶	14 3 x 10 ⁻⁶	1. 75 x 10 ⁴	1.46×10^{17}	3.90 × 10 ³	2. 64 x 10 ⁷	0. 03 DB INCREASE IN VSW 0. 28 DB INCREASE IN INSE
13 × 10 ¹³	;	#1 × 10 ⁻⁰	14 3 x 10 ⁻⁶	1	1, 95 × 1017	4 65 x 10 ³	3.57×10^{7}	0. 22 DB INCREASE IN INSE 0. 52 DB INCREASE IN ISOI
19×10^{13}	4 11	42×10^{-6}	14. 7 x 10 ⁻⁶	1. 70 × 10 ⁴	$\frac{1}{1}$ $2 \cdot \sigma 2 \times 10^{17}$	4. 19 × 10 ³	3.66×10^7	NO CALIBRATION ON MON 0. 09 DB INCREASE IN INSE
$\frac{41 \times 10^{13}}{86 \times 10^{12}}$, , 1	42×10^{-13}	14.7 x 10-6	1. 70 x 10 ⁴	$\begin{array}{c} 2.40 \times 10^{17} \\ 1.66 \times 10^{17} \end{array}$	$\begin{array}{c} 4.15 \times 10^{3} \\ 4.40 \times 10^{3} \end{array}$	$\frac{4.34 \times 10^7}{3.02 \times 10^7}$	0. 16 DB INCREASE IN INSF 0. 07 DB INCREASE IN INSF
86 \ 1012	1.0 ± 	$\frac{12 \times 10^{-6}}{42 \times 10^{-6}}$	14.7×10^{-6} 14.7×10^{-6}	$\begin{array}{c} 1.70 \times 10^{4} \\ 1.70 \times 10^{4} \end{array}$	1, 68 x 10 ¹⁷	4. 15 \ 103	3.02×10^{7}	0. 11 DB INCREASE IN INSE
05×10^{12}		11 × 10 ⁻⁶	14 3 \ 10-6	1. 75 x 10 ⁴	1.84 \times 10 ¹⁶	3.80×10^3	3.48×10^7	0. 10 DB DECREASE IN MO. 0. 15 DB INCREASE IN INSE
$\frac{52 \times 10^{42}}{48 \times 10^{13}}$	+ 4 (4)	41 × 10 ⁻⁶	14. 3 x 10 ⁻⁶ 14. 3 x 10 ⁻⁶	1.75 x 10 ⁴ 1.75 x 10 ⁴	$\begin{array}{ccc} + & & 1.67 \times 10^{10} \\ & 2.59 \times 10^{17} \end{array}$	$\begin{array}{c} 3,20 \times 10^{3} \\ 4.80 \times 10^{3} \end{array}$	$\begin{array}{c} 3.04 \times 10^{7} \\ 4.66 \times 10^{7} \end{array}$	0. 15 DB INCREASE IN INSE 0. 23 DB INCREASE IN ISOI
52×10^{12}	. , ‡	41 × 10 ⁻⁶	14.3 x 10 ⁻⁶	; 1, 75 x 10 ⁴	1.67×10^{16}	3.20×10^3	3.01×10^{7}	0. 06 DB INCREASE IN INSE 0. 08 DB INCREASE IN INSE
07 × 10 ¹³		4.0×10^{-6}	17 1 × 10 · 0	1, 46 x 10 ⁴	1, 56 x 10 ¹⁷	4.35×10^{3}	2.81×10^{7}	0. 10 DB INCREASE IN MON
46×10^{13}	•		17.1 \ 10-6	1. 46 x 10 ⁴	2.13×10^{17}	3.30×10^{3}	3.85×10^{7}	0. 09 DB INCREASE IN INSE 0. 07 DB INCREASE IN INSE
15×10^{13}	:		. 15.7 × 10 ⁻⁶		1 63 × 10 ¹⁷	$\frac{1}{2}$ 3.50 x 10 ³	3.30×10^{7}	0. 18 DB IN
43×10^{13}	: :		15.7 × 10 ⁻⁶		2.27 × 1017	$= 3/90 \times 10^3$	4.11×10^{7}	0. 15 DB DI 0. 07 DB IN 2. 0 DB INC

1	12	13	14	15	16	17
SE TH SEC.)	REACTOR PERIOD IT (SEC.)	R (1 SEC)	PEAK INCIDENT NEUTRON FLUX REn 0.01 (CALCULATED) (NEUTRONS cm ² SEC.)	STERRITED (AMMA) (IOSE D _{RT} (RADS)	PEAK INCIDENT GAMMA DOSE Dgr (RADS SEC.)	RADIATION EFFECT ON COMPONENTS
10 ⁻⁶	14.3×10^{-6}	1.75×10^4	1 27 × 10 ¹⁷	· · · · · · · · · · · · · · · · · · ·	2. 28 x 107	0.04 DB INCREASE IN MONITOR SIGNAL PL& P2
10-6	$14/3 \times 10^{-6}$	1.75×10^4	1.64×10^{17}	$^{6-5} \leq 10^{3}$	2.97×10^{7}	0.04 DB DECREASE IN INSERTION LOSS P1 & P2 0.09 DB INCREASE IN INSERTION LOSS
10-6	14. 3 × 10 ⁻⁶	1.75×10^4	1 60 5 1017	$2^{-6}\theta \ge 10^{\frac{3}{2}}$	2.94×10^{7}	0. 03 DB INCREASE IN VSWR SIGNAL 0. 23 DB INCREASE IN INSERTION LOSS
10 ⁻⁶	14/3 x 10°6	1, 75 x 10 ⁴	2.00×10^{17}	3, 40 x 10 ³	3, 50 x 10 ⁷	
10 ^{- ti}	14. 0 x 10 ⁻⁶	1, 79 × 10 ⁴	$\epsilon_{-13} \propto 10^{16}$	2.50×10^{3}	1.46 × 10 ⁷	0.05 DB DECREASE IN MONITOR SIGNAL P1 & P2
10 ⁻⁶	14. 0 x 10 ⁻⁶	1.79×10^4	1.58×10^{47}	35×10^{3}	2. 85 x 10 ⁷	0. 18 DB INCREASE IN INSERTION LOSS P1 & P2 0. 07 DB INCREASE IN INSERTION LOSS
10 ⁻⁶	14. 0 x 10 ⁻⁶	1 79 104	2.06×10^{17}	3 (O) x 10 ³	3.72×10^{7}	0. 11 DB INCREASE IN INSERTION LOSS
10-1	14.0 × 10±6	1, 79 x 10 ⁴	1 97 < 1017	4.07×10^3	3.57×10^7	6. 14 DB INCREASE IN INSERTION LOSS 0. 52 DB INCREASE IN ISOLATION
10-6	14 0 x 10 ⁻⁴	1. 79 x 10 ¹	7.63×10^{16}	2. 55 x 10 ³	1.37×10^{7}	0. 05 DB DECREASE IN INSERTION LOSS P1 & P2
10 ⁻¹⁵	14. 0 × 10 ⁻⁶	1. 79 × 10 ⁴	$e.27 \times 10^{17}$	4.15×10^3	2.47×10^{7}	0. 07 DB INCREASE IN INSERTION LOSS
10 ⁻⁶	14 0 x 10 ⁻⁶	1.79×10^4	$_{1-46}$ $_{3-16}$ 17	3.41×10^3	2. 46 x 107	0. 02 DB INCREASE IN VSWR SIGNAL 0. 26 DB INCREASE IN INSERTION LOSS
10-ti	$14/0 \times 10^{-6}$	1.79×10^{4}	2.35×10^{17}	4.41 x 10 ³	4.26 x 10 ⁷	0. 21 DB INCREASE IN INSERTION LOSS 0. 50 DB INCREASE IN ISOLATION
[()= [†] 1	$14/3 \times 10^{-6}$	1.75×10^{4}	$< 70 \times 10^{16}$	2 67× 103	1. 21 x 10 ⁸	NO CALIBRATION ON ADAPTER RETURN SIGNAL
ų h	14, 3 × 10 ⁻⁶	1.75 × 104	1. 34 × 1017	4.80×10^{3}	2.42×10^{7}	0. 10 DB INCREASE IN INSERTION LOSS
() tr	14/3 x 10 ⁻⁶	1, 55 × 19 [‡]	1.46×10^{17}	3. 90 x 10 ³	2.64×10^{7}	0. 03 DB INCREASE IN VSWR SIGNAL 0. 28 DF INCREASE IN INSERTION LOSS
o=6	14 3 × 10° ⁴	$1.75\times 10^{\frac{1}{4}}$	1 301 × 1017	4, 63 x 10 ³	$3,57 \times 10^{7}$	0. 22 DB INCREASE IN INSERTION LOSS 0. 52 DB INCREASE IN ISOLATION
10 %	147×10^{-6}	1.70×10^4	$2/\alpha_{\rm e}^{\alpha} \propto 10^{1.7}$	4.19×10^3	3, 66 x 10^7	NO CALIBRATION ON MONITOR SIGNAL 0.09 DB INCREASE IN INSERTION LOSS P1 & P2
(0=!) (0=!)	14.7 × 10° ⁶ 14.7 × 10° ⁶	1.70×10^4 1.70×10^4	$\frac{2.40 \times 10^{17}}{1.68 \times 10^{17}}$	4, 15 x 10 ³ 4, 40 x 10 ³	4. 34 x 107 3. 02 x 107	0. 16 DB INCREASE IN INSERTION LOSS 0. 07 DB INCREASE IN INSERTION LOSS
i0-4	11.7 × 10-4	1.70×10^4	1, 68 x 1017	4. 15 x 103	3. 02 x 107	0. 11 DB INCREASE IN INSERTION LOSS
i. '	14.3×10^{-8}	1.75×10^4	1.74×10^{16}	$\approx -3,80 \times 10^3$	$3/48 \times 107$	0. 10 DB DECREASE IN MONITOR SIGNAL P1 & P2 0. 15 DB INCREASE IN INSERTION LOSS P1 & P2
lo ^{-t} lo ^{-t} :	14 3 × 10 ⁻⁶	1 75 × 10 ⁴	$\begin{array}{c} 1.67 \times 10^{16} \\ 2.59 \times 10^{17} \end{array}$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\frac{3.01 \times 10^{7}}{4.66 \times 10^{7}}$	0. 15 DB INCREASE IN INSERTION LOSS 0 23 DB INCREASE IN ISOLATION
10-6	14 3 × 10°5	1 75 × 10 ⁴	1 + 7 × 10 ¹⁶	3, 20 × 10 ³	3 01 × 10 ⁷	0. 06 DB INCREASE IN INSERTION LOSS 0. 08 DB INCREASE IN INSERTION LOSS
	14 3 × 10 ⁻¹	1.75×10 ⁴	1 56 × 10 ¹⁷	4.3×10^{3}	2.81×10^{7}	0. 10 DB INCREASE IN INSERTION 1.088 0. 10 DB INCREASE IN MONITOR SIGNAL PL& P2
10-1 10-1	17 1 × 10 ⁻¹⁰	1, 46 × 10 ⁴	2 13 × 10 ¹⁷	3.30×10^{3}	3.85×10^{7}	0. 09 DB INCREASE IN INSERTION LOSS 0. 07 DB INCREASE IN INSERTION LOSS
	17. 1 × 10 ⁻¹	1 46 × 10†			_	;
10*** 10***	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\frac{1.59 \times 10^4}{4.59 \times 10^4}$	$\frac{1.83 \times 10^{17}}{2.27 \times 10^{17}}$	$\frac{7.50 \times 10^{3}}{3.50 \times 10^{3}}$	3.30×10^{7} 4.11×10^{7}	0 16 DB INCREASE IN MONITOR SIGNAL PL& P2 0, 15 DB DECREASE IN INSERTION LOSS P2 0, 07 DB INCREASE IN INSERTION LOSS
				•		2. 0 DB INCREASE IN ISOLATION



SYMBOL DEFINITIONS FOR TABLE VI

= DIFFERENCE BETWEEN CENTER OF RADIATION BURST AND CENTER OF P1 (MICROSECONDS) $\mathbf{E}_{\mathbf{ns}}$ = INTEGRATED NEUTRON FLUX 3.0 Mev (NEUTRONS cm²) = INTEGRAL NEUTRON FLUX 1.5 Mev (NEUTRONS cm²) E_n1.5 . 145 INTEGRAL NEUTRON FLUX 0.7 Mev (NEUTRONS cm²) $E_n^{0.6}$ INTEGRAL NEUTRON FLUX 0.01 Mev (NEUTRONS cm²) $\mathbf{E}_{\mathbf{n}}^{0.01}$ - FIRST COLLISION TISSUE DOSE OF NEUTRONS (RADS) = 1.66 x 10^{-8} E $_{\rm ns}$ where 1.66 x 10^{-8} is an empirical number RADIATION PULSE WIDTH AT ONE-HALF MAXIMUM OBTAINED FROM SPRF PHOTOGRAPH (SECONDS) T_{w} = REACTOR PERIOD = $\frac{1}{2.86}$ T_W WHERE $\frac{1}{2.86}$ IS AN EMPIRICAL NUMBER (SEC.) T RATIO OF PEAK NEUTRON FISSION RATE TO THE TOTAL NEUTRON R 1 4 T FISSIONS D_{g} INTEGRATED GAMMA DOSE (RADS) PEAK GAMMA DOSE RATE (RADS SEC.) D_{gr} NOTES:

- * Power level delivered to the component under test, $\frac{1}{l}$ Low cw \sim 100 milliwatts
- * Positive sign indicates the center of the radiation burst was ahead of the center of P1.
- *** $E_{\rm n}$ 0.01 was calculated assuming $E_{\rm ns} =$ 0.145 $E_{\rm n}$ 0.01.

the radiation burst was ahead

0.145 1 0.01

1	2	3	4	5
BURST NUMBER	COMPONENT EXPOSED	POWER LEVEL *	S** (MICROSECONDS)	(NEUTRON FLUX Ens (NEUTRONS cm ²)
9	COAXIAL DUPLEXER	HI PULSED	- 5	2. 09 x 10 ¹²
	W, G CIRCULATOR	LOW CW	ł 	1. 45 x 10 ¹²
	ALUMINUM W G (AIR FILLED)	rom cm		1. 03 \(\) 10 ¹² 1. 49 \(\) 10 ¹²
10	COAXIAL DUPLEXER	HI PULSED	+15	2 79 x 10 ¹²
	W/G CIRCULATOR W/G DUPLEXER ALUMINUM W/G (AIR FILLED)	LOW CW LOW CW		1. 59 x 10 ¹² 1. 20 x 10 ¹² 1. 89 x 10 ¹²
11	w g circulator	HI PULSED	- 5	1, 34 × 1012
	W G DUPLEXER	LOW CW		16 x 1012
12	W G CIRCULATOR	HI PULSED	- 3	1 39 × 10 ¹²
	W G DUPLEXER COAXIAL LIMITER	LOW CW		$\begin{array}{c c} 1.35 \times 10^{12} \\ 1.21 \times 10^{12} \end{array}$
13	W G CIRCULATOR	HI PULSED	-10	40 × 1012
14	W, G CIRCULATOR	LOW CW	-42	: 49 x 10 ¹²
15	W, G CIRCULATOR COAXIAL LIMITER	LOW CW	-30	$\begin{array}{c} 1 & \text{if } x 10^{12} \\ \text{for } x 10^{12} \end{array}$
16	, W G CIRCULATOR	LOW CW	-15	. St \$ 10 ¹²
17	w.gcirculator	LOW CW	-	. 49 x 10 ¹²
	ALUMINUM W G (HI DENSITY POLY)	LOW CW		$_{1.5^{\circ}\times10^{12}}$
18	COAXIAL CL. TULATOR	HI PULSED	0	$1 - 16 \times 10^{12}$
	COAXIAL LIMITER COAXIAL CIRCULATOR ALUMINUM W G (HI DENSITY POLY)	LOW CW LOW CW		$\begin{array}{c} 1.37 \times 10^{12} \\ 1.16 \times 10^{12} \\ 1.52 \times 10^{12} \end{array}$

2

TABLE VI. NEUTRON AND Y-RAY DOSIMETRY WE DIVIDING INTEGRAL DOSE AND DO TO THE MICROWAVE COMPONENTS AND THE OBSERVED EFFECTS (

3		5	to to	7	8	9	10	11	1.
POWER LEVEL.*	eMic RO Feesth.	INTEGRATED NEUTRON FLUX	INTEGRATED 1	NEUTRON FLUX (NEUTRONS cm ²)	T	INTEGRATED NEUTRO- FLUX *** E _n 0.01 (CALCULATE)	NEUTRON TISSUE IXXE D _n	PULSE WIDTH	REACTO PERIO
	:	(NEUTRONS cm ²)	E _n 1.5	E _n 0. 6	E _n 0. 01	(NEUTRONS cm ²)	(RADS)	T _w (SEC.)	T (SEC
HI PULSED		2. 09 x 10 ¹²				1. 44 x 10 ¹³	3. 47 x 10 ⁴	50 x 10 ⁻⁶	17 5 x 1
Low cw		1. 45×10^{12}	1	i 		1. 00 x 10 ¹³	2.41×10^4	50 × 10 ⁻⁶	17 5 % 1
TOM C.M.		1. 03 x 10 ¹² 1. 49 x 10 ¹²]		$\begin{array}{c} 7.\ 10 \times 10^{12} \\ 1.\ 03 \times 10^{13} \end{array}$	1.71 x 10 ⁴ 2 47 x 10 ⁴	50 x 10 ⁻⁶ 50 x 10 ⁻⁶	17.6×1 17.5×1
ні руцзыр		2. 79 x 10^{12}	1.75×10^{12}	3. 76 x 10 ¹²	4. 91 x 10 ¹²	1. 92 x 10 ¹³	1 63 x 10 ⁴	46 x 10 ⁻⁶	- 16. 1 x ⁻¹
LOW CW LOW CW		1. 59 x 10 ¹² 1. 20 x 10 ¹² 1. 89 x 10 ¹²	1			1. 10 x 10 ¹³ 5. 26 x 10 ¹ 1. 00 x 10 ¹	$\begin{array}{c} 2.64 \times 10^{\frac{4}{3}} \\ + 2.8 \times 10^{\frac{1}{3}} \\ + 2.8 \times 10^{\frac{1}{3}} \end{array}$	46 x 10 ⁻⁶ 46 x 10 ⁻⁶ 46 x 10 ⁻⁶	16. 1 × · · · · · · · · · · · · · · · · · ·
HI PULSED		1. 34×10^{12}	1. 67 x 10^{12}	3.16×10^{12}	4. 55 x 10 ¹²	9. 24 x 10 ¹²	2.22×10^4	50 x 10 ⁻⁶	17.5%
TOM CA		1. 16×10^{12}				8.00×10^{12}	1 93 x 10 ⁴	50 x 10 ⁻⁶	17.5 x
н вазы		1.39×10^{12}			1	9, 59 x 10 ¹²	31 x 10 ⁴	50 x 10 ⁻⁶	17 5 x
LOW CW		$\begin{array}{c} 1.35 \times 10^{12} \\ 1.21 \times 10^{12} \end{array}$:	9. 31 x 10 ¹² 8. 34 x 10 ¹²	$\frac{24 \times 10^4}{2.01 \times 10^4}$	50 x 10 ⁻⁶ 50 x 10 ⁻⁶	17. 5 x 17. 5 x
HI PULSED		1. 40 x 10 ¹²				9. 66 x 10 ¹²	32×10^4	50 x 10 ⁻⁶	17 3 x
LOW CW		1. 19 x 10 ¹²			•	8. 21 x 10 ¹²	1. 38 x 10 ⁴	° 60 × 10−6	21 9 5
TOM ∈# TOM ∈#		$\begin{array}{c} 1.51 \times 10^{12} \\ 1.50 \times 10^{12} \end{array}$		ı		1. 04 x 10 ¹³ 1. 0 x 10 ¹³	2.51×10^4 2 $\times 10^4$	50 x 10 ⁻⁶ 50 x 10 ⁻⁶	17.5 × 17.5 ×
I OW CW		1. 33 x 10^{12}	3.02×10^{12}	5.54×10^{12}	$\sim 25 \times 10^{12}$	9. 17×10^{12}	$^{\circ}$ 21 x 10 4	52 x 10 ⁻⁶	18 2 ×
$1.0W \in W$		1, 49 x 10^{12}				1. 03 x 10^{13}	$^{\circ}~47\times10^{4}$		
$\mathrm{LO}W \subseteq \mathcal{W}$		1. 76×10^{12}				r. 21 x 10 ¹³	$\approx 92 \times 10^4$		
ш ретяно		1. 18×10^{12}	2.85×10^{12}	5.34×10^{12}	7, 77 x 1012	8. 14 x 10 ¹²	: 96 x 10 ⁴	50 x 10 ⁻⁶	17. 5 ×
LOW CW LOW CW		$\begin{array}{c} 1.37 \times 10^{12}_{1} \\ 1.18 \times 10^{12} \\ 1.52 \times 10^{12} \end{array}$!	· ·	9. 45 x 10 ¹² 8. 14 x 10 ¹² 1. 05 x 10 ¹³	2 27 x 10 ⁴ 1, 96 x 10 ⁴ 2 52 x 10 ⁴	50 x 10 ⁻⁶ 50 x 10 ⁻⁶ 50 x 10 ⁻⁶	17. 5 x 17. 5 x 17. 5 x

3

DOSIMETRY PRO . NIEGRAL DOSE AND DOSE RATE EXPOSURES WAVE COMPONES ... THE OBSERVED EFFECTS (SHEET 2)

MAYE COMPONES	THE CAPTER APP		,				
9 TED NEUTRON LUX *** (CALCULATED) TRONS, cm ²)	PULSE WIDTH F., (SEC.)	REACTOR PERIOD T (SEC.)	R (1, SEC.)	PEAK INCIDENT NEUTRON FLUX REn 0.01 (CALCULATED (NEUTRONS cm ² SEC.)	15 INTEGRATED GAMMA DOSE Dgr (RADS)	PEAK INCIDENT GAMMA DOSE Dgr (RADS SEC.)	RADIATION
. 44 x 10 ¹³	NO X 10-6	17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴	2. 06 x 10 ¹⁷	4. 05 x 10 ³	3. 72 x 10 ⁷	0. 15 DB INCREASE IN MO
. 00 x 10 ¹³	<0 x 10 ^{−6}	17. 5 x 10-6	1. 43 x 10 ⁴	1. 43 x 10 ⁷	3. 25 x 10 ³	2. 59 x 10 ⁷	0. 06 DB DECREASE IN INS 0. 12 DB INCREASE IN INS NO CALIBRATION ON VSW
. 10 x 10 ¹² . 03 x 10 ¹³	$\frac{50 \times 10^{-6}}{50 \times 10^{-6}}$	17. 5 x 10 ⁻⁶ 17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴ 1. 43 x 10 ⁴	2. 45 x 10 ¹⁶ 1. 47 x 10 ¹⁷	2. 65 x 10 ³ 3. 45 x 10 ³	$\begin{array}{c} 1.83 \times 10^{7} \\ 2.65 \times 10^{7} \end{array}$	0. 36 DB INCREASE IN INS
l. 92 x 10 ¹³	$\approx \times 10^{-6}$	16. 1 x 10 ⁻⁶	1. 55 x 10 ⁴	2. 98 x 10 ¹⁷	5. 60 x 10 ³	5. 38 x 10 ⁷	0. 17 DB INCREASE IN MO
. 10 x 10 ¹³ 6 x 10 ¹² 6 x 10 ¹³	40×10^{-6} 40×10^{-6} 40×10^{-6}	16. 1 x 10 ⁻⁶ 16. 1 x 10 ⁻⁶ 16. 1 x 10 ⁻⁶	1.55 x $10^{\frac{4}{1}}$ 1.55 x $10^{\frac{1}{1}}$ 1.55 x $10^{\frac{1}{1}}$	1.71 x 1017 1.25 x 1017 2.02 x 10	3.25×10^{3} 2.95×10^{3} 3.50×10^{3}	3 07 x 107 2.1.3 x 101 3.00 x 101	1. 12 DB INCREASE IN INS 0. 15 DB INCREASE IN INS 1. 10 DB INCREASE IN INS 1. 10 DB INCREASE IN INS
. 24 x ₁₀ 12	· · 10-6	17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴	1. 32 x 10 ¹⁷	1.85 x 10 ³	2.38×10^{7}	0. 04 DB INCREASE IN MO
i. 00 x 10 ¹²	5.6×10^{-6}	17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴	1. 14 x 10 ¹⁷	2. 90 x 10 ³	2. 07 x 10 ⁷	0. 10 DB DECREASE IN P1 0. 16 DB INCREASE IN INS
1.59×10^{12}		17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴	1.37×10^{17}	2.95 x 10 ³	2. 48 x 10 ⁷	0. 03 DB INCREASE IN MO 0. 11 DB INCREASE IN INS
l. 31 × 10 ¹² l. 34 × 10 ¹²	50×10^{-6}	17. 5 x 10 ⁺⁶ 17. 5 x 10 ⁺⁶	1. 43 x 10 ⁴ 1. 43 x 10 ⁴	1. 33 x 10 ¹⁷ 1. 19 x 10 ¹⁷	$\begin{array}{c} 1.90 \times 10^{3} \\ 2.30 \times 10^{3} \end{array}$	$\begin{array}{c} 2.40 \times 10^{7} \\ 2.16 \times 10^{7} \end{array}$	0. 24 DB INCREASE IN INS 0. 02 DB INCREASE IN VSV
), 66 $ imes$ 10^{12}	0×10^{-6}	17 5 x 10 ⁻⁶	1. 43 x 10 ⁴	1. 38 x 10 ¹⁷	3. 15 \times 10 ³	2, 49 x 10 ⁷	0. 02 DB INCREASE P1, 0. 0. 07 DB INCREASE INSER
$1.21 imes 10^{12}$	v 10 ^{-ti}	21. 0 x 10 ⁻⁶	1. 19 x 10 ⁴	9.77 x 10 ¹⁶	2. 55 x 10 ³	1.77×10^{7}	0. 09 DB INCREASE IN INC
. 04 × 10 ¹³ . 0 × 10 ¹³	$\frac{40 \times 40^{-6}}{2.5 \times 10^{-6}}$	17. 5 x 10-6 17. 5 x 10-6	1. 43 x 10 ⁴ 1. 43 x 10 ⁴	1. 49 x 10 ¹⁷ 1. 49 x 10 ¹⁷	$\begin{array}{c} 3.65 \times 10^{3} \\ 3.6 \times 10^{3} \end{array}$	$\begin{array}{c} 2.69 \times 10^{7} \\ 2.6 \times 10^{7} \end{array}$	0. 10 DB INCREASE IN INS 10 DB INCREASE IN SIGNA
. 17 $\propto 10^{12}$	$.2 \times 10^{-6}$	18. 2 x 10 ⁻⁶	1.37×10^4	1. 26 x 10 ¹⁷	2.80×10^{3}	2.27×10^{7}	0. 11 DB INCREASE IN INS
1.03×10^{13}					3, 15 x 10^3	i	0. 06 DB INCREASE IN MO
. 21 х 10 ¹³			т.		2.40×10^{3}		0. 15 DE INCREASE IN INS 0. 21 DB INCREASE IN INS
. 14 × 10 ¹²	t < 10**	17, 5 x 10 ⁻⁶	· 1.43 x 10 ⁴	1. 16 x 10 ¹⁷	2.85×10^3	2.40×10^{7}	0. 22 DB DECREASE IN MC
$\begin{array}{l} .45 \times 10^{12} \\ .14 \times 10^{12} \\ .05 \times 10^{13} \end{array}$	0×10^{-6} 0×10^{-6} 0×10^{-6}	17. 5 x 10 ⁻⁶ 17. 5 x 10 ⁻⁶ 17. 5 x 10 ⁻⁶	1. 43 x 10 ⁴ 1. 43 x 10 ⁴ 1. 43 x 10 ⁴	1. 35 x 10 ¹⁷ 1. 16 x 10 ¹⁷ 1. 50 x 10 ¹⁷	2. 85 x 16 ³ 2. 85 x 10 ³ 2. 00 x 10 ³	$\begin{array}{c} 2.44 \times 10^{7} \\ 2.10 \times 10^{7} \\ 2.70 \times 10^{7} \end{array}$	0. 08 DB DECREASE IN INS 0. 09 DB INCREASE IN INS NO CALIBRATION VSWR S 0. 20 DB INCREASE IN INS

DOSE RATE EXPOSURES TS (SHEET 2)

	·· -,				
12	13	14	15	16	17
CTOR RIOD EC.)	R (1 SEC.)	PEAK INCIDENT NEUTRON FLUX RE _n 0.01 (CALCULATED (NEUTRONS, cm ² SEC.)	INTEGRATED GAMMA DOSE Dgr (RADS)	PEAK INCIDENT GAMMA DOSE Dgr (RADS SEC.)	RADIATION EFFECT ON COMPONENTS
x 10 ⁻⁶	1. 43 x 10 ⁴	2.06 x 10 ¹⁷	4, 05 x 10 ³	3. 72 x 10 ⁷	0. 15 DB INCREASE IN MONITOR SIGNAL P1 & P2
x 10-6	1. 43 x 10 ⁴	1. 43 x 10 ⁷	3.25×10^3	2.59 x 10 ⁷	0. 06 DB DECREASE IN INSERTION LOSS P2 0. 12 DB INCREASE IN INSERTION LOSS NO CALIBRATION ON VSWR SIGNAL
x 10-6	1. 43 x 10^4	2. 45 x 10 ¹⁶	2.65×10^{3}	1.83 x 107	
x 10 ⁻⁶	1. 43 x 10^4	1. 47 x 10 ¹⁷	3, 45 x 10^3	2.65×10^{7}	0. 36 DB INCREASE IN INSERTION LOSS
x 10-6	1.55×10^4	2. 98 x 10 ¹⁷	5. 60 x 10 ³	5.38×10^{7}	0. 17 DB INCREASE IN MONITOR SIGNAL P1 & P2 1. 12 DB INCREASE IN INSERTION LOSS P1 & P2
x 10 ⁻⁶	1. 55 \times 10 ⁴	1.71×10^{17}	3, 25 x 10^3	3. 07 x 107	0. 15 DB INCREASE IN INSERTION LOSS
$\propto 1 \cdot \frac{9}{6}$	1 1 :	1. 5 \$ 1012	$\begin{array}{c} 2.95 \times 10^{3} \\ 3.50 \times 10^{3} \end{array}$	1.1 (1.1)	9, 19 DB PACREAST IN INSPIRITON LOSS
X 11 "	the second section	2.02 × 10	3, 50 X 10°	100 × 10°	A. L. DE P.CRI AST IN P.STRHON TOSS
x 10 ⁻⁶	. 1. ±3 x 10 ⁴	1.32×10^{17}	1, 85 x 10^3	2.38×10^{7}	0. 04 DB INCREASE IN MONITOR SIGNAL P1 & P2 0. 10 DB DECREASE IN P1, 0. 02 DB DECREASE P2 INSERTION LOSS
x 10 ⁻⁶	1, 43 x 10 ⁴	1. 14 \times 10 ¹⁷	2.90×10^3	2.07×10^7	0. 16 DB INCREASE IN INSERTION LOSS
x 10 ⁻⁶	1. 43 x 10 ⁴	1 37 \ 1017	2. 95 $\times 10^3$	2. 48 x 107	0. 03 DB INCREASE IN MONITOR SIGNAL P1 & P2 0. 11 DB INCREASE IN INSERTION LOSS P1 & P2
x 10 ⁻⁶ⁱ	1. 43 x 10 ⁴	1.33×10^{17}	1. 90 x 10 ³	2. 40 x 10 <u>1</u>	0. 24 DB INCREASE IN INSERTION LOSS
x 10-ti	1. 43 x 10^4	1. 19 x 10 ¹⁷	2. 30 × 10^3	2.16×10^7	U. 02 DB INCREASE IN VSWR SIGNAL
x 10 ⁻⁶	1. 43 x 10 ⁴	1. 38×10^{17}	3, 15 x 10^3	2. 49 x 10 ⁷	0. 02 DB INCREASE P1, 0. 02 DB DECREASE P2 MONITOR SIGNAL 0. 07 DB INCREASE INSERTION LOSS P1
x 10 ⁻⁶	1. 19 × 10 ⁴	9.77×10^{16}	2.55×10^{3}	1.77×10^{7}	0. 09 DB INCREASE IN INSERTION LOSS
x 10-6	1, 43 x 10 ⁴	1.49×10^{17}	3, 65 x 10^3	2.69 x 10 ⁷	0. 10 DB INCREASE IN INSERTION LOSS
x 10-6	1. 43 × 10 ⁴	1. 49 x 1017	3, 6 $\times 10^3$	2.6×10^{7}	10 DB INCREASE IN SIGNAL LEVEL FROM OUTPUT PORT
x 10 ⁻⁶	1. 37 × 10 ⁴	1.26×10^{17}	2, 80 x 10 ³	2.27 x 107	0. 11 DB INCREASE IN INSERTION LOSS
			$3,15\times10^3$		0. 06 DB INCREASE IN MONITOR SIGNAL
			2.40×10^{3}		0. 15 DB INCREASE IN INSERTION LOSS 0. 21 DB INCREASE IN INSERTION LOSS
x 10°6	1, 43 × 10 ⁴	1.46×10^{17}	2.85×10^3	2.10×10^{7}	0. 22 DB DECREASE IN MONITOR SIGNAL P1 & P2 0. 08 DB DECREASE IN INSERTION LOSS P1 & P2
x 10-6	1. 43×10^4	1.35 \times 10 ¹⁷	2.85×10^{3}	2.44×10^{7}	0. 09 DB INCREASE IN INSERTION LOSS
x 10-6	1.43×10^4	1.16×10^{17}	2.85×10^{3}	2.10×10^{7}	NO CALIBRATION VSWR SIGNAL
x 10 ⁻⁶	1.43×10^4	1.50×10^{17}	2.00×10^3	2.70×10^{3}	0. 20 DB INCREASE IN INSERTION LOSS
x 10-6 x 10-6 x 10-6	1, 43 × 10 ⁴ 1, 43 × 10 ⁴ 1, 43 × 10 ⁴			2. 44 × 10 ⁷ 2. 10 × 10 ⁷ 2. 70 × 10 ⁷	

5. CONCLUSIONS

The following conclusions are based on the operation of C-band microwave components at power levels of 100 milliwatts (low power) and 5 kilowatts (high power) at a frequency of 5.6 Gc and in a radiation environment of the content and duration of that produced during a burst at the SPRF. The radiation effects on the operating characteristics of the components are the following:

5.1 WAVEGUIDE TO COAXIAL ADAPTERS

The average transient decrease in the signal level passing through the adapters using rexolite beads was approximately 0.1db at low rf power. Under the same operating conditions, the average transient decrease in the signal level passing through the adapters using polyethylene beads was less than 0.2 db or approximately twice that of the rexolite beads. Transient effects observed at high rf pulsed power were of comparable magnitude.

5.2. ALUMINUM WAVEGUIDE SECTIONS

Air ionization effects in waveguide have been noted in previous experiments. Tests performed during this interim using carefully selected adapters (Rexolite beads) are consistent with the previous conclusions. Solid dielectric inserts reduce the ionization effects and thus the transient increase in insertion loss per foot; however these inserts increase the static insertion loss of the waveguide by approximately an order of magnitude.

5.3. COAXIAL ISOLATOR

The radiation effects observed were less than 0.1 db. The device seems to be fully acceptable for use in a radiation environment.

5.4 COAXIAL CIRCULATOR

The high and low power transient effects observed for this device are less than 0.05 db. This device seems to be fully operational in a transient radiation environment.

5.5 COAXIAL LIMITER

The transient radiation effects observed for this device at low r-f power are less than 0.1 db and are thus acceptably low. At high power the signal level out of the limiter increases by approximately 10 db. The basic source of this effect is

believed to be associated with the teflon bead used for the single crystal sphere holder and cross strip spacer. Some redesign and additional tests on the device seem required to produce a fully radiation resistance gyromagnetic coupling limiter.

5.6 COAXIAL DUPLEXER

This device composed of the coaxial Y-junction circulator and the coaxial limiter seem to be acceptable for use in a radiation environment. The observed average transient radiation effects were less than 0.2 db. The isolation provided by the circulator seems to reduce the rf power reaching the limiter to a magnitude below that producing the adverse effects observed in the tests of the limiter alone. This of course, depends on the application and system environment of the duplexer.

5.7 WAVEGUIDE JUNCTION CIRCULATOR

The average transient radiation effects observed for this component at low or high power are less than 0.15 db. The operation of this device seems acceptable for utilization in a radiation environment.

5.8 WAVEGUIDE DIFFERENTIAL PHASE SHIFT DUPLEXER

The average transient radiation effects observed for this component at low or high power are less than 0.3 db. A large portion of this observed effect is possibly associated with the waveguide-to-coax adapters required to perform the tests. The actual radiation effects in the duplexer proper is probably near 0.1 db.

5.9 MAGNETRON AND FREQUENCY METER

Tests on the bare magnetron operating in the pulse radiation environment produced no deterioration in the pulse shape or magnitude. Previous experiments which included the pulse transformer and associated circuitry produced results showing large decreases in output power during and just after the radiation burst. These effects are attributed to the pulse transformer and circuitry supplementary to the magnetron. The magnetron itself apparently operates without deterioration during the radiation burst.

The observed signals from the frequency meter tests could not be fully analyzed. However, the characteristics of the transmission cavities apparently were altered during the burst producing large excrusions in the output signal.

5.10 GENERAL

In general, the effects of the radiation experimental tests during this period agree well with those reported for previous periods. With the exception of the coaxial

limiter, the observed effects at high r-f power levels (5 Kw) agree well with those observed at low cw power.

The operating characteristics of all the ferrite duplexing components tested in the pulsed radiation environment (with the possible exception of the coaxial gyromagnetic coupling limiter) are not altered severely. Each component would be acceptable for utilization toward radiation resistant or hardened microwave system.

The significance of these conclusions to the microwave equipment designer is as follows:

The gyromagnetic coupling limiters can not be expected to retain their full limiting characteristic when exposed to pulsed radiation and high rf power. In critical power limiting situations, some degree of radiation resistant development will be needed for the limiter to perform properly. All of the other components tested seem fully acceptable for utilization in radiation resistant microwave equipment.

The significance of these conclusions to the microwave tube designers is the following:

The magnetron (MA-220) and pulse transformer exhibited large transient effects during the radiation burst and recovery time (lingering effects) are long (much longer than 150 microseconds). The magnetron itself exhibits radiation resistant characteristics. Radiation effects in the pulse transformer and associated driver circuitry produce the observed deteriorating effects.

The significance of these conclusions to inclividuals engaged in the study of radiation damage mechanisms is the following:

Ionization produced by gamma rays and the resultant electrons is the most prominent radiation damage mechanism observed in the studies of transient radiation effects on mi crowave duplexing equipment.

6. REFERENCES

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- 7. Private communication with P. D. O'Brien.
- 8. Private communication with L. L. Flores.
- 9. Plankis, E. P., "Radiation Effects on Microwave Devices," Report No. 3 Contract No. DA-36-039-SC-87253, Third Quarterly Progress Report, General Electric Co., Power Tube Department, p 69 and p 73.

7. PROGRAM FOR NEXT INTERVAL

(1 MARCH 1964 TO 31 JULY 1964)

The data collected during the entire program will be further analyzed and integrated. A thorough analysis and interpretation of the results of the program will be formalized leading to the preparation of the final report.

8. IDENTIFICATION OF PERSONNEL

During the sixth quarter (1 November to 29 February), 567 engineering manhours were devoted to the contract by the personnel listed below.

Biographies of all personnel have appeared in previous reports submitted on the program.

B. J. Duncan	9	hours
E. W. Matthews	27	hours
G. R. Harrison	95	hours
R. E. Greenwood	112	hours
J. A. Hart	281	hours
D. B. Swartz	43	hours

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